

Measurement of the scintillation time spectra and pulse-shape discrimination of low-energy β and nuclear recoils in liquid argon with DEAP-1

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Abstract

The DEAP-1 low-background liquid argon detector was used to measure scintillation pulse shapes of electron and nuclear recoil events and to demonstrate the feasibility of pulse-shape discrimination down to an electron-equivalent energy of 20 keV_{ee}.

In the surface dataset using a triple-coincidence tag we found the fraction of β events that are misidentified as nuclear recoils to be $< 1.4 \times 10^{-7}$ (90% C.L.) for energies between 43–86 keV_{ee} and for a nuclear recoil acceptance of at least 90%, with 4% systematic uncertainty on the absolute energy scale. The discrimination measurement on surface was limited by nuclear recoils induced by cosmic-ray generated neutrons. This was improved by moving the detector to the SNOLAB underground laboratory, where the reduced background rate allowed the same measurement to be done with only a double-coincidence tag.

The combined data set contains 1.23×10^8 events. One of those, in the underground data set, is in the nuclear-recoil region of interest. Taking into account the expected background of 0.48 events coming from random pileup, the resulting upper limit on the level of electronic recoil contamination is $< 2.7 \times 10^{-8}$ (90% C.L.) between 44–89 keV_{ee} and for a nuclear recoil acceptance of at least 90%, with 6% systematic uncertainty on the absolute energy scale.

We developed a general mathematical framework to describe pulse-shape-discrimination parameter distributions and used it to build an analytical model of the distributions observed in DEAP-1. Using this model, we project a misidentification fraction of approximately 10^{-10} for an electron-equivalent energy threshold of 15 keV_{ee} for a detector with 8 PE/keV_{ee} light yield. This reduction enables a search for spin-independent scattering of WIMPs from 1000 kg of liquid argon with a WIMP-nucleon cross-section sensitivity of 10^{-46} cm², assuming negligible contribution from nuclear recoil backgrounds.

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1. Introduction

The ability to separate electron-recoil (β - γ) interactions from nuclear-recoil interactions is critical for many nuclear and particle astrophysics experiments, including direct searches for dark matter particles. Liquid argon provides very sensitive pulse-shape discrimination based on scintillation timing [1], and it is a favourable target for dark matter particle searches since it can be used to construct a very large target mass detector. It is the target of choice in ArDM [2], MiniCLEAN [3], DarkSide [4], and WARp [5] detectors. In this paper we present results on the pulse-shape discrimination of β - γ events from nuclear recoils with the DEAP-1 liquid argon detector, substantially extending the initial analysis [6].

Argon has many desirable properties as a scintillator, among them a high light yield of approximately 40 photons per keV [7] and ease of purification, so that it can meet the radio-purity requirements of a rare-event search experiment. However, argon that is condensed from the atmosphere is known to contain cosmogenically-produced ^{39}Ar , which undergoes β -decay at a rate of approximately 1 Bq per kg [8, 9]. The scintillation properties of liquid argon provide a method for discriminating these β -decays from WIMP interactions in the detector [1].

Scintillation in argon is a result of the formation of excited dimers after exposure to ionizing radiation [10]. These occur in singlet and triplet states. On decaying to the ground state, they emit light at a peak wavelength of 128 nm, lower in energy than the lowest excited atomic state [11, 12]. The scintillation light can thus pass through pure argon without being absorbed.

The scintillation yield of nuclear recoils in liquid argon is quenched to about 0.25(2) [13] of the yield for electron recoils⁷. When referring to energies of nuclear recoils, units of either keV_{ee} (“electron equivalent”) or keV_{r} are used, with the latter being the full energy of the recoil, and $[\text{keV}_{\text{r}}]=0.25 \cdot [\text{keV}_{\text{ee}}]$.

The two argon dimer states have vastly different lifetimes, about 6 ns for the singlet and approximately 1.5 μs for the triplet state [12]. Moreover, the relative population of singlet and triplet states is determined by the linear energy transfer (LET), such that fewer triplet excimers are produced at higher LET, and by the track structure of the exciting radiation [12, 16]. With the large difference in lifetimes, the percentage of light signal in the first few tens of nanoseconds is a good estimate for the relative population of the singlet state, allowing for an effective way to discriminate between particles of different LETs, such as low-energy electrons and nuclei. The exact value of the triplet state lifetime is debated in the literature and values as low as

1110 ns [17] and as high as 1590 ns [12] have been reported (for a review of recent results see Ref. [18]).

Measurements of the pulse-shape discrimination of β - γ events from nuclear recoils in liquid argon have also been reported in [19] and [4]. In this work the upper limit on the β - γ event misidentification probability is improved by a factor of ~ 5 , due to higher statistics. A new improved analytic model for the pulse-shape discrimination parameter distribution, presented in Section 5, is consistent with the data and provides a more general framework than the previously used ratio-of-Gaussians model from Ref. [6]. It has been applied to the case of a much larger detector.

2. Experimental apparatus

The target volume of the DEAP-1 detector (shown in Fig. 1) is a cylinder 28 cm in length and 15 cm in diameter, containing 5.1 L (7 kg) of liquid argon at about 87 K. It is defined by a 1/4-inch thick polymethylmethacrylate (PMMA) sleeve and two PMMA windows, which were coated on the inside, using standard vacuum deposition techniques, with a roughly 0.1 mg/cm^2 thick layer of the wavelength-shifter 1,1,4,4-tetraphenyl-1,3-butadiene (TPB) [20]. The TPB shifts the 128 nm liquid argon scintillation light to the visible range so that it may pass the glass and acrylic windows. In order to increase scintillation light collection efficiency, the outside of the acrylic sleeve is coated in TiO_2 paint (Bicron BC-620) for the first two datasets presented here and wrapped in Gore® Diffuse Reflector for the third dataset.

The target volume is contained inside a cylindrical stainless steel ultra-high vacuum shell with a 6-inch diameter glass window on each end. An 8-inch long cylindrical PMMA light guide rests against each glass window. The stainless steel shell and part of each light guide are located inside a 12 inch diameter PMMA acrylic vacuum chamber, and further thermally insulated by multi-layer super-insulation. The light guides are o-ring sealed to PMMA flanges on the insulating acrylic vacuum chamber, and the outer light guide face is at laboratory atmosphere and room temperature. A ETL 5” 9390B photo multiplier tube (PMT) is coupled to each lightguide using Bicron BC-630 optical gel and operated at room temperature.

The light guides allow the PMTs to be operated at room-temperature by thermally insulating them from the liquid argon target volume (the measured heat load in this configuration is approximately 7 watts per light guide) while at the same time transporting visible light from the target volume. The lightguides also moderate neutrons emitted from the PMT glass so that the background rate in the target volume is reduced. They are constructed from UV-absorbing (UVA) acrylic to minimize potential backgrounds from Čerenkov radiation generated by cosmic-ray muons.

⁷We are aware of more recent results of approximately 0.29[14, 15], which is slightly higher. Changed quenching factor does not affect our conclusions significantly.

All detector components were selected to minimize radioactivity in the target volume, in particular neutrons from (α, n) interactions in detector materials.

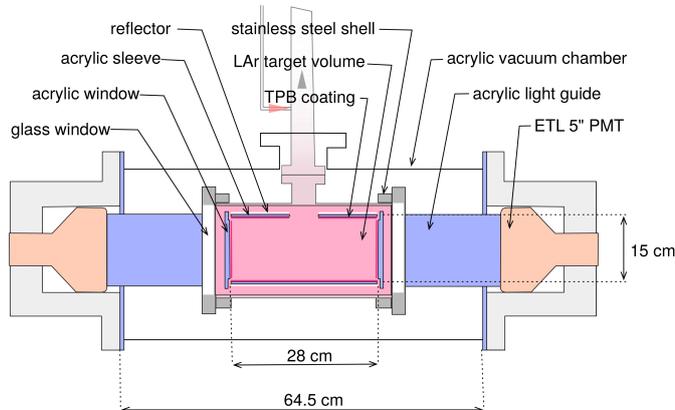


Figure 1: DEAP-1 detector configuration. Liquid argon is contained in a stainless steel target chamber, which includes an inner acrylic cylinder painted with or wrapped in diffuse reflector and coated on the inside with TPB. Flow directions of liquid argon and boil-off vapor are indicated with arrows. Scintillation light from the liquid argon is wavelength-shifted by the TPB and transmitted to PMTs operating at room temperature through PMMA acrylic lightguides. The PMTs (5-inch ETL 9390B) are held in place by spring-loaded polyethylene supports, which maintain contact between the PMTs and lightguides.

The argon is cooled by passing it through a 50-foot-long coil immersed in a liquid-nitrogen tower. The nitrogen is maintained at an absolute pressure of 32.5 to 33.5 psi. There is an auto-fill system connected to an external 230 L Dewar to maintain nitrogen level. The argon passes through a 1/4-inch tube to the neck of the argon chamber. Argon which boils from the top of the chamber flows in gas phase through an argon return line to the top of the cooling tower, located above and slightly to the side of the target chamber. During operation the gas-phase flow rate of argon is 2.5 standard litres per minute through the return line.

The absolute pressure of the argon chamber was typically 13 psia which corresponds to a temperature of 86.5 K. The temperature is higher in the argon chamber than in the nitrogen tower because of heat loads from conduction through the light guides, heating from the residual gas in the insulating vacuum and heating by conduction through metal components of the argon chamber. These processes are described in [21].

At the top of the tower there is an argon inlet port which is normally valved off. During fill ultra-high purity (grade 5.0) argon is passed through a SAES getter [22] at rates between 5 and 12 standard litres per minute. (The return line is valved off for fill forcing the gas to pass through the cooling coil.) The argon at the outlet of the purification system contains less than 1 ppb of impurities. For the underground dataset, an

additional charcoal trap [23], maintained at -110 C, was used to remove the trace amounts of radon in the argon.

The target chamber is surrounded by a neutron and γ -ray shield consisting of a minimum of two layers of ultra-pure water in 12-inch cubical polyethylene containers, for a total water shielding thickness of 60 cm. A Geant4 [24, 25] Monte-Carlo simulation showed that the water shield is sufficient to reduce nuclear recoil events in the liquid argon from external-source (α, n) neutrons to less than one per year.

The data presented here come from three datasets: 67 days of operation in the surface laboratory at Queen’s University without any overburden for cosmic-ray shielding; and ≈ 1 month and ~ 9 months of measurements underground at SNOLAB [26] at a depth of 6000 meters water equivalent. At that depth the cosmic-ray muon flux passing through the detector is of the order of one per year, reduced from approximately 10 per second at Queen’s University. The first dataset at SNOLAB was a period of testing of the data acquisition and optimization of triggering. Between the first and second data sets at SNOLAB the acrylic sleeve was replaced and the bicron paint was replaced with Gore Tex reflector.

Details on data analysis (see Sec. 3.3), data-quality cuts (see Sec. 3.4) and detector stability (see Sec. 4.2) are included. The surface and two underground datasets had similar light yield and comparable stability, which justifies extracting the upper limit on pulse-shape discrimination from the combined dataset, presented in Sec. 4.4. For the sake of comparison with the analytic model, discussed in Sec. 5, surface and long underground datasets are treated individually, in order to better account for small differences in light yield, resolution, noise parameters and associated systematic uncertainties. The short underground dataset is not used in detailed fitting to the model. We refer to the longer underground dataset as “V1720 data” for reasons that will be apparent in the next sections.

3. Data and analysis

3.1. Electronics and Trigger Configurations

Signals from the PMTs are sent to Phillips 778 amplifiers. One output of each amplifier is sent to a digitizer, either LeCroy digitizing oscilloscope (1 sample per ns) or CAEN V1720 board (1 sample per 4 ns), that samples the waveforms for 10 μ s, many times the 1.6 μ s lifetime of the longest component of scintillation light. The second output of the amplifier is passed to a linear fan-out with one of the two outputs being used for discriminator triggering and the other for more sophisticated triggers. The discriminator for each PMT was set at 5 mV, which corresponds to ≈ 0.25 of the mean single photoelectron (SPE) pulse height. The “DEAP-1” trigger is a signal above discriminator threshold within ± 20 ns in both PMTs, corresponding to approximately 1 keV_{ee}, well below the region of interest for this study.

The remaining output from the linear fan-out for each PMT is passed to a summing amplifier and then to a shaping amplifier with an integration time of 6 μ s. This summed signal is passed to a single-channel analyzer (SCA) and used as a veto for events far larger in energy than the region of interest. Cutting these high-energy events allows us to increase the effective data-taking rate by a factor of approximately 3. The DEAP-1 trigger with this veto imposed is called the “DEAP-1 SCA” trigger.

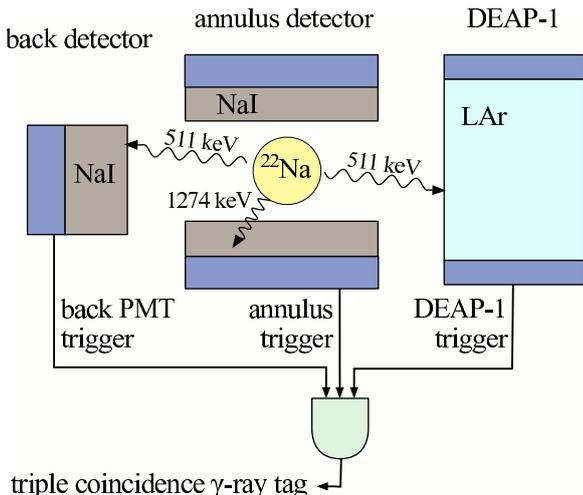


Figure 2: Calibration source geometry. The decay of ^{22}Na is tagged by γ 's in the back NaI PMT, the annulus detector, and in DEAP-1, which allows a very low non- γ background for calibration of the pulse-shape discrimination.

The response of DEAP-1 to electromagnetic interactions in the liquid argon is calibrated by a 10 μ Ci encapsulated ^{22}Na source placed outside of the argon chamber. The source emits a positron and a 1274 keV γ -ray. The positron annihilates in the source container producing back-to-back 511 keV γ -rays. One of the 511 keV γ -rays scatters in the argon.

For the dataset at Queen's University we used two additional detectors to “tag” the backwards going 511 keV γ -ray and the additional 1274 keV γ -ray. The source is placed on the axis of an annular NaI detector with dimensions $3.75'' \times 11.5'' \times 12''$ (inner diameter \times outer diameter \times length) to detect the 1274 keV γ -ray. The annulus is divided into 4 sections along its axis with a PMT on each section. The signals from the 4 sections of the annulus are independently amplified (Phillips 778) and discriminated (Phillips 705) with the threshold set just below the 1274 keV peak. The outputs of the discriminators are passed to a logical OR (Phillips 775 with coincidence level 1) to generate the “annulus trigger”. The four annulus sections also have a higher-energy discriminator which is used as a veto on the annulus trigger to reduce backgrounds from cosmic rays.

A cylindrical NaI crystal of dimension $3.25'' \times 3''$ (diameter \times length) coupled to a PMT is placed at one end of the annulus. This PMT signal is amplified and passed to a single-channel amplifier (Ortec 420) which is centered on the 511 keV peak to detect the “backwards” going gamma ray. The “back PMT” trigger is thus generated. The “global tag” is generated when an annulus trigger and a back PMT trigger are coincident. The geometry of this triple-coincidence tag is shown in Fig. 2. The location of the source and back PMT are optimized to maximize the coincidence rate with the annulus. The distance between the source and the center of the DEAP-1 detector was $\simeq 17''$.

For background runs and AmBe neutron calibration runs the DEAP-1 trigger was used. (Some AmBe data was also taken with the DEAP-1 SCA trigger to ensure that this trigger did not bias the acceptance of high F_{prompt} events below 300 PE.) For ^{22}Na data, runs were taken with either the DEAP-1 trigger in coincidence with the tag, or the DEAP-1 SCA trigger in coincidence with the tag. Runs using the DEAP-1 trigger with the tag allowed the measurement of the light yield at the full-energy 511 keV gamma peak whereas runs with the DEAP-1 SCA trigger took advantage of higher rate acquisition for PSD studies in the region of interest [27]. The timing of the triggering is such that approximately 1 μ s of the waveform is recorded before the leading edge of the event. Furthermore, in tagged events, the leading edge of the waveform measures the relative timing of the tag and the measurement of light in the detector.

For the datasets at SNOLAB we used only the cylindrical NaI crystal to tag the “backwards” going gamma ray. Because the mechanical constraints of the annulus were removed we were able to position the source $\simeq 13''$ from the center of the argon cylinder. In the first underground dataset the location of the tagging PMT was varied from run to run as the tagging was optimized. The tagging NaI crystal was then kept at approximately 2'' from the source for the V1720 dataset.

3.2. Data Flow

For the dataset at Queen's University and the first data at SNOLAB, the signal from each PMT is recorded with a Lecroy digitizing oscilloscope (1 sample per nanosecond) at a “high-gain” setting of 50 mV/division. When higher-energy signals are of interest the signals are recorded at both the high-gain setting and a low-gain setting of 500 mV/division on a second channel.

A Linux data-acquisition computer runs an event builder that reads the files in real time and converts them to a ROOT-based [28] format. The root-based data files are automatically transferred to a disk farm on the High-Performance Computing Virtual Laboratory (HPCVL) [29] for offline analysis. For the triple-coincidence calibration, the rate of scattering events in

the argon is approximately 10 kHz, the rate of back-PMT and annulus coincidences is approximately 100 Hz, and the triple-coincidence rate is approximately 20 Hz.

For the first dataset at SNOLAB, the oscilloscope was used with 1 sample per 1, 2, or 4 ns depending on the run. The V1720 dataset at SNOLAB was recorded with a CAEN V1720 waveform digitizer recording 1 sample per 4 ns for 16 μ s.

3.3. Analysis

Figure 3 shows PMT traces from a sample γ -ray event in the region of interest from PSD calibration. A linear baseline correction is applied waveform-by-waveform: the baseline is found in the first 0.5 μ s of the waveform trace. (This is done with an iterative procedure to remove regions where random pulses occurred.) That baseline is used to search for signals above threshold in the final 4 μ s of the pulse. Areas around these signals are removed and a baseline is calculated at the end of the pulse. A linear function is found from the two baseline regions and subtracted from the total trace. The mean of the waveforms in the pre-signal and late-signal region were calculated and used as cuts in the analysis.

The leading edge for each signal is found using a voltage threshold of 5 mV, which corresponds to approximately one quarter of a photoelectron. The prompt region of the pulse is defined from 50 ns before the edge to 150 ns after the edge. The late region is defined from 150 ns to the end of the waveform, $\simeq 9 \mu$ s after the leading edge. The total charge for each PMT for both prompt and late regions is found and converted to units of photoelectrons using the single photoelectron charge calibration described below. Defining $Q_{\text{prompt,late}}^{\text{A,B}}$ as the number of photoelectrons (PE) in PMT A or B that are prompt or late, and TotalPE as the total number of photoelectrons in the entire waveform for both PMTs, we write the fraction of prompt light as

$$F_{\text{prompt}} \equiv \frac{Q_{\text{prompt}}^{\text{A}} + Q_{\text{prompt}}^{\text{B}}}{\text{TotalPE}}. \quad (1)$$

The relative signals in the two PMTs are used to reconstruct the position of the event, Z_{fit} , along the cylindrical axis of the detector,

$$Z_{\text{fit}} \equiv 35.2 \text{ cm} \times \frac{Q^{\text{A}} - Q^{\text{B}}}{\text{TotalPE}}, \quad (2)$$

where $\text{TotalPE} \equiv Q_{\text{prompt}}^{\text{A,B}} + Q_{\text{late}}^{\text{A,B}}$ and 35.2 cm is the distance from the center of the cylinder to the front face of the PMT.

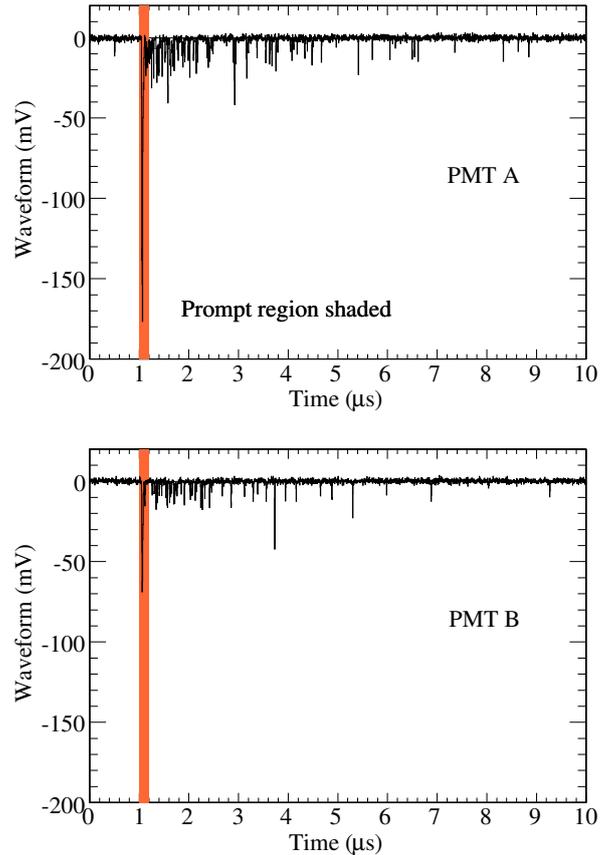


Figure 3: A sample event from a ^{22}Na PSD calibration run. Shown are the recorded traces for each of the two PMTs, labeled A and B. The shaded area shows the prompt region which begins 50 ns before the leading edge of the pulse and ends 150 ns after the leading edge.

The Z_{fit} variable was calibrated using only the back PMT and the DEAP-1 detector with the back PMT pulled farther back to precisely define the direction of the forward gamma ray. The ^{22}Na source and back PMT were scanned along the axis of the detector, with a typical calibration result shown in Fig. 4. The spatial resolution depends on energy, and ranges from $\sigma \approx 1$ cm for high-energy alphas, through 5 cm at 511 keV peak (approx. 1400 PE), to broader resolution of up to 10 cm in 120–240 PE window.

Because background rates were highest near the ends of the detector, a cut was performed in this analysis to look only at events in the middle of the detector, thus reducing the probability of an accidental coincidence between a tag and a high- F_{prompt} event. Example Z_{fit} distributions and efficiency of the Z_{fit} -based cut will be discussed later.

The time between leading edges δt for the two PMTs is found. All data are passed through a cut requiring $|\delta t| < 20$ ns. This cut eliminated a small number of events in which the hardware trigger was satisfied but the waveform was not characteristic of a single scin-

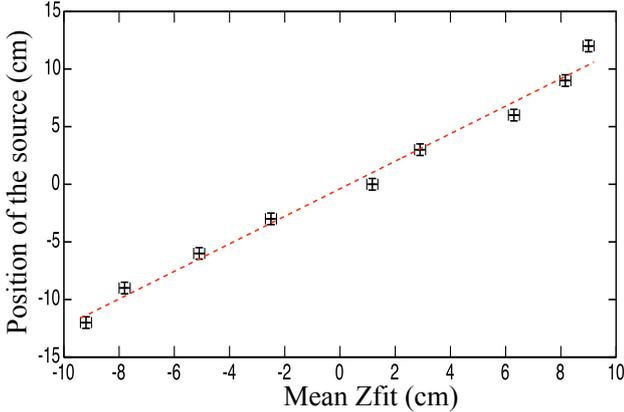


Figure 4: Position of the 511 keV γ source along the detector versus mean Z_{fit} . The error bar on the source position corresponds to the physical size of the source. Horizontal error bars on mean Z_{fit} come from the Gaussian fit to the data. Linear regression is shown in red.

tillation event. This distribution is centered at a small negative value that may be due to differing transit times in the two PMTs or cable length.

The average leading edge time of the two PMTs, t_{edge} , is used in ^{22}Na data to define a time window in software for accepting events in DEAP-1 with respect to the time of the back-PMT signal. For PSD analysis, a cut is imposed that accepts only events whose leading edge time is within 30 ns of the mean time as found by a Gaussian fit to the distribution. This cut was defined to include almost all legitimate coincidences while reducing the time window for random pileup of tags with high- F_{prompt} backgrounds, described later. Figure 5 shows the timing distributions for a typical PSD run.

The mean charge from single photoelectrons (SPE) is derived from these data. Using only pulses with a low number of photoelectrons (below 200), we scan the final 4 μs of the pulses (high-gain channel only) looking for signals crossing a threshold of 5 mV, compared to a typical 20 mV height of an SPE pulse. These signals are integrated from 5 ns before the threshold crossing to 20 ns after the threshold crossing (a total of 26 samples). On a run-by-run basis these baseline corrected SPE charges are collected in a histogram. The mean charge is determined by the iterative procedure outlined in Refs [30, 31] that finds the mean between 0.4 and 2.5 times the previous value until convergence is achieved. Figure 6 shows histograms for a typical run. The mean charges for the two PMTs are 1.73 and 1.82 pC, with a variation throughout the running period of less than 4%.

The main advantage of the above method is speed and robustness in tracking run-to-run variations even on low statistics or noisy data, without any assumptions about the shape of the distribution. For more accurate absolute SPE charge calibration, additional information about the SPE charge distribution is needed, in partic-

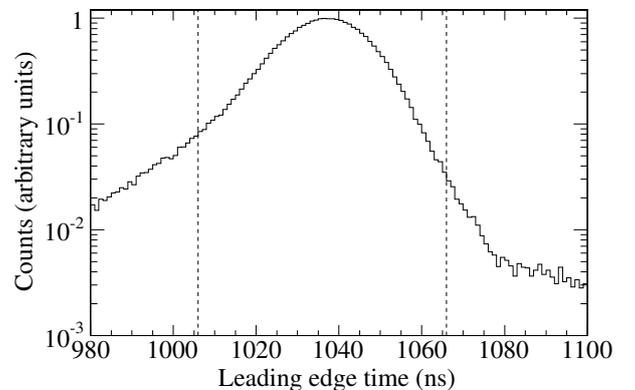
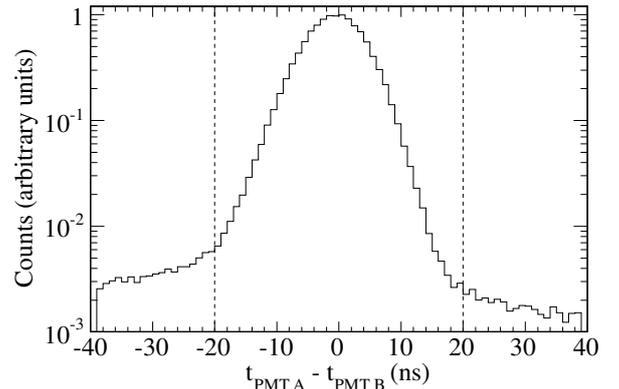


Figure 5: The timing distributions for a typical surface dataset run for events with $120 < \text{TotalPE} < 240$ and Z_{fit} in the central 20 cm of the detector. The vertical lines indicate the cut values. For the top plot the cuts are always imposed at ± 20 ns. For the bottom plot the mean value is determined by a Gaussian fit and the cuts are imposed at the mean ± 30 ns.

ular about the under-amplified component of the SPE spectrum, induced by photons hitting directly the first dynode, which manifests as a low-charge shoulder on the SPE peak, and generally overlaps with the pedestal. As a cross-check, we exercised fitting the charge spectrum with an SPE model function chosen as a double peak gamma distribution or a Gaussian function⁸. Ultimately, we assign 10% systematic uncertainty to the absolute value of the mean SPE charge, which is motivated by comparison with results returned by other SPE models.

The energy response is calibrated throughout the data taking mainly with the 511 keV peak from ^{22}Na .

⁸In later generations of DEAP-1 [32], supplied with larger 8 in. Hamamatsu R5912-HQE PMTs, an LED pulser was installed to address the systematic uncertainties in the SPE charge calibration.

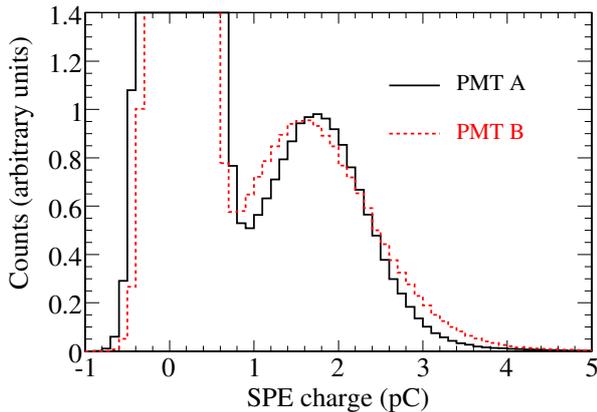


Figure 6: Single photoelectron spectra of the DEAP-1 PMTs, used to calibrate the absolute light yield and number of detected photons.

The position and the width of the 511 keV annihilation peak is determined from a fit to a superposition of a linear and a Gaussian function, as shown in Fig. 7.

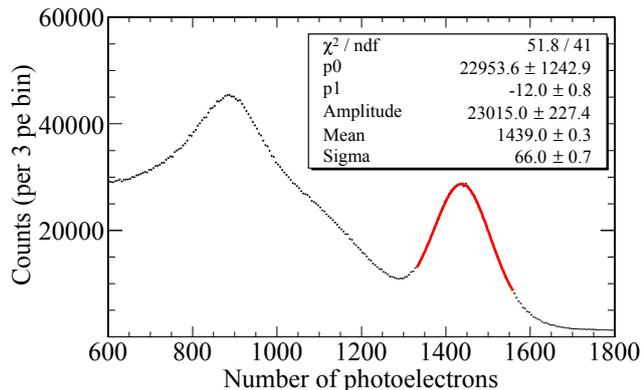


Figure 7: The spectrum from the ^{22}Na source used for energy calibration, zoomed in to show both the 511 keV annihilation peak and its Compton edge. A model function consisting of the first order polynomial ($p_0 + p_1 * x$) and a Gaussian function is used to fit the 511 keV peak and thus obtain an energy calibration.

The average light yield is approximately 2.8 ± 0.1 and 2.7 ± 0.1 photoelectrons per keV_{ee} for the surface and underground datasets, respectively, where keV_{ee} is the electron-equivalent energy. These numbers and uncertainties were estimated from weighted average of the ^{22}Na peak positions over the entire dataset (for further details on the energy response stability, see Sec. 4.2). The light yield has an additional 10% systematic uncertainty from the SPE charge calibration, as discussed earlier, and a downward systematic uncertainty of $-0.2 \text{ PE}/\text{keV}_{\text{ee}}$ F_{prompt} , defined as in Eq. (1), versus number of photoelectrons at 59.5 keV (decreasing toward higher energies) due to

a likely systematic over-counting of the number of photoelectrons (see Sect. 5.1.3).

Light yield from ^{22}Na calibrations is consistent with results of routinely performed calibrations with the 59.5 keV gamma from an Americium-Beryllium (Am-Be) source, with the position of the Compton edges associated with 1461 and 2615 keV gammas from natural radioactivity in the detector surroundings [23], and with 81 keV and 356 keV ^{133}Ba lines [21].

3.4. Effect of Data-Quality Cuts

Data-quality cuts for the dataset taken underground at SNOLAB with the V1720 digitizers were studied in detail to ensure there was no bias in the F_{prompt} distributions.

The cuts were optimized to decrease the relative rate of accidental coincidences between tags and random backgrounds based on detailed study of the backgrounds in the detector. The cut conditions are given below (some cuts used in the surface dataset differ from the ones used in the V1720 underground dataset):

1. $120 < \text{TotalPE} < 240$
2. $-12 \text{ cm} < Z_{\text{fit}} < 10 \text{ cm}$ in the V1720 underground dataset or $\text{abs}(Z_{\text{fit}} + 1.8) < 10 \text{ cm}$ in the surface dataset.
3. $|\delta t| < 20 \text{ ns}$ (after time-zero calibration).
4. Leading edge time within $\pm 20 \text{ ns}$ of mean in the V1720 underground dataset or within $\pm 30 \text{ ns}$ of mean in the surface dataset.
5. Prompt and late charges for each PMT correspond to a positive number of photoelectrons.
6. The mean value of the leading edge baseline is within 1 mV of the mean for the run (eliminates events with signal in the leading baseline from pileup). The mean value of the trailing-edge baseline is within 6 mV of the mean for the run.

The effects of cuts are shown in Figure 8 for ^{22}Na and Am-Be neutron events, and in Figure 9 for one full-spectrum ^{22}Na run, both recorded with the V1720 digitizers. The numerical values of events after all cuts for the Am-Be runs are shown in Tab. 1.

4. Results

4.1. Surface run

Data were collected with the DEAP-1 detector between August 20th and October 16th, 2007. A total of 63,072,900 triple-coincidence ^{22}Na calibration events were recorded for the PSD analysis.

Figure 10 shows for these events the distribution of F_{prompt} versus number of photoelectrons. In this data set a hardware threshold imposed

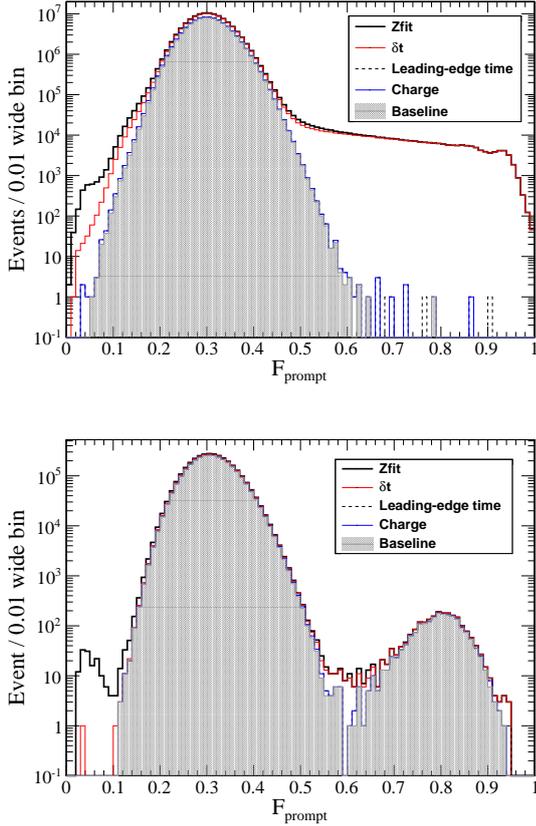


Figure 8: The F_{prompt} distributions for all SNOLAB ^{22}Na data (top) taken with the V1720 and for all Am-Be runs (bottom) taken with the V1720 shown after the incremental imposition of the cuts (enumerated in the text). For PSD running most high F_{prompt} events are eliminated by ensuring that the timing between the leading edge of the waveforms and the tag was as expected. The dashed entries were cut by ensuring all charges had physical values. The remaining unfilled entries were removed with cuts on the baseline values. One event, consistent with accidental coincidence, remains above 0.7. For neutron data the cut efficiencies are used in determining the neutron acceptance.

with the SCA restricts the high-photoelectron events to approximately 300 photoelectrons. Analysis of neutron calibration data shows that this does not remove high- F_{prompt} ($0.7 < F_{\text{prompt}} < 1$) nuclear recoil events.

Figure 11 shows the F_{prompt} versus photoelectron distribution for neutrons and γ -rays from an Am-Be calibration source. We used this calibration dataset to determine the region of interest in F_{prompt} for nuclear recoil events. The position of the mean from the Gaussian fit (with $F_{\text{prompt}} > 0.65$ restriction) in each bin is taken as the 50% recoil acceptance threshold, while higher acceptance thresholds are derived from fitted mean and standard deviation using Gaussian quantiles. This approach was chosen, as opposed to calculating the nuclear recoil band quantiles directly from the data, in order to avoid biases due to overlap with the electronic recoil

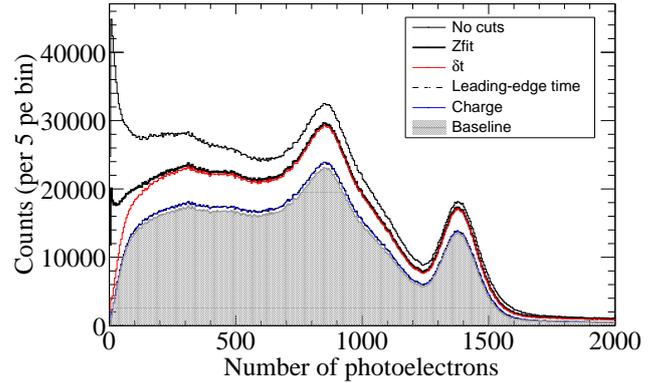


Figure 9: The TotalPE distributions for a full-spectrum ^{22}Na run taken at SNOLAB with the V1720 electronics. Cuts are applied incrementally, as in Fig. 8.

	$F_{\text{prompt}} < 0.7$	$F_{\text{prompt}} > 0.7$
TotalPE	4.20×10^6	2.54×10^3
Z_{fit}	3.23×10^6	1.99×10^3
δt	3.15×10^6	1.99×10^3
Leading-edge time	3.01×10^6	1.86×10^3
Charge	3.01×10^6	1.86×10^3
Baseline	2.99×10^6	1.84×10^3

Table 1: The number of events surviving each cut for Am-Be calibration events is tabulated.

band in the lowest energy bins. Using the fitted mean and sigma results in F_{prompt} corresponding to a given acceptance that is: (1) consistent to 0.01 with quantiles from the data for the entire 120–240 PE range and (2) conservative, i.e. always lower than from the direct method.

As shown in Section 5, we expect to use pulse-shape discrimination for signals of approximately 120 photoelectrons and above. We therefore pre-determined the region of interest for demonstration of PSD to be 120–240 photoelectrons and $0.7 < F_{\text{prompt}} < 1.0$, corresponding in DEAP-1 to approximately 43–86 keV_{ee} and a nuclear recoil acceptance of not less than 90% (uncertainties on the nuclear recoil band position and width are taken into account conservatively). Figure 12, which shows the F_{prompt} distribution for γ -rays and nuclear recoils for events between 120 and 240 photoelectrons, was used to evaluate the PSD performance. We find that none of the 16.7 million γ -ray events leak into the nuclear recoil region, and infer from these data that the PSD in liquid argon⁹ at 90% nuclear recoil acceptance

⁹Despite the fact that the ^{22}Na deposited energy spectrum is softer than ^{39}Ar β spectrum, PSD for both event sources in DEAP-1 is nearly the same (see Sec. 5.4).

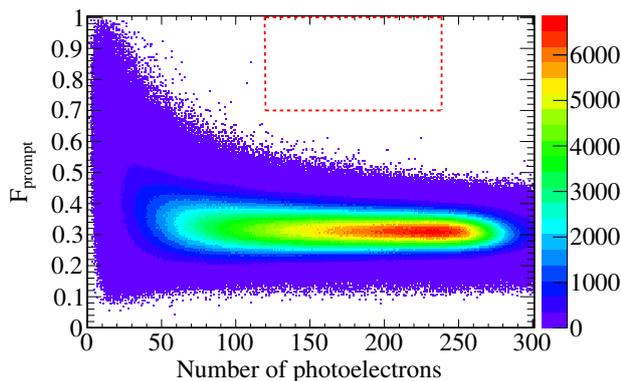


Figure 10: F_{prompt} versus energy distribution for the triple-coincidence γ -ray events. The linear color scale (color online) reflects the number of counts per bin of 0.005 by 1 PE size. The region between 120–240 photoelectrons for $F_{\text{prompt}} > 0.7$ contains no events. The threshold was set based on the projected discrimination of ^{39}Ar in the large detector (not based on this data set).

is less than 6×10^{-8} .

We have also repeated this analysis with a lower photoelectron threshold and higher F_{prompt} region. For a neutron detection efficiency of 50%, there is one contamination event observed between 70–240 photoelectrons (approximately 25–86 keV_{ee}), for an observed pulse-shape discrimination of 4.7×10^{-8} in that range.

4.2. Detector stability

Several tests of detector stability were performed.

The light yield is approximately 2.8 ± 0.1 and 2.7 ± 0.1 photoelectrons per keV_{ee} for the surface and underground run, respectively (see Figures 13 and 14). It was stable within a few per cent throughout both running periods, although a slight degrading systematic trend can be seen, which is factored into the uncertainty through the weighted average.

Impurities in the argon can decrease the light yield by absorbing UV photons or by quenching argon dimers before they decay, thereby also decreasing the observed lifetime of the triplet state in liquid argon [18, 33]. Therefore, we measured the triplet lifetime in DEAP-1 over the course of the run to check that impurities did not build up in the detector over time and to look for possible correlations with the light yield.

We use ^{22}Na calibration data to measure the triplet lifetime. For each calibration run, we find all events that

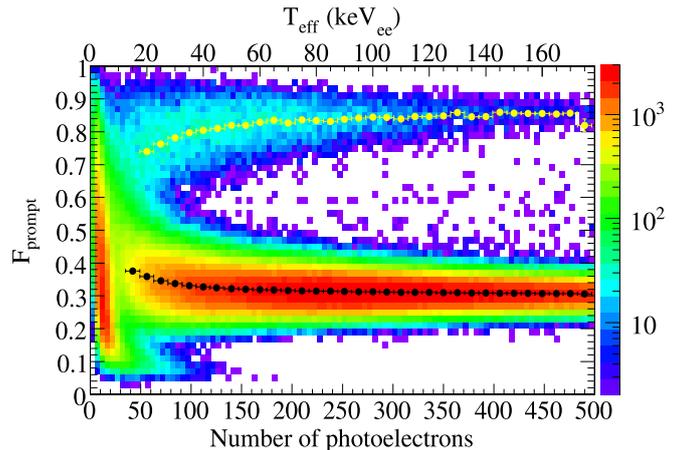


Figure 11: F_{prompt} versus energy distribution for neutrons and γ rays from an Am-Be calibration source. The logarithmic color scale (color online) reflects the number of counts per bin of 0.02 by 5 pe size. The upper band is from neutron-induced nuclear recoils in argon. The lower band is from background γ -ray interactions. Gaussian fits to the F_{prompt} distribution are performed separately for both bands, in each of 5 keV_{ee} slices of the spectrum from 15–200 keV_{ee} range for γ -ray and 20–200 keV_{ee} range for neutron-induced events. Fits are constrained to 0.2–0.5 and 0.65–1.0 F_{prompt} ranges for electronic and nuclear recoils, respectively, to avoid introducing significant biases due to the bands overlap. Resulting most likely F_{prompt} values are shown as black and yellow points for the lower- and upper-band, respectively. The change in the mean F_{prompt} values when going to lower energies likely dominated by a systematic effect (see Sec. 5.1.3).

pass the data cleaning cuts and contain over 200 photoelectrons. The raw traces for these events are aligned according to the measured trigger positions and summed. We then fit the following model to the average trace between 500 and 3000 ns from the trigger:

$$f(t) = A \exp(-t/\tau_3) + B, \quad (3)$$

where A is a normalization factor, τ_3 is the triplet lifetime and B is a constant baseline term. There are systematic effects associated with the linear baseline correction discussed in Section 3.3, which motivated including only the 500–3000 ns region in the fit, as in the later part of the average trace the exponential decay trend becomes skewed.

As a consistency check, we measured τ_3 for photoelectron bins of size 200 between 200 and 1600 photoelectrons and did not observe any systematic effect from the signal size. We estimated the size of the error associated with both the baseline correction and the fit window to be 40 ns by changing the start and end times of the fit by 500 ns. We performed the fit for both corrected and uncorrected traces and estimated the size of the error associated with the baseline to be 50 ns. We added the two estimated systematic errors to determine a combined systematic error of 60 ns.

The measured lifetimes over the course of the run for traces without the baseline correction are shown in Figures 15 and 16, in which the error bars shown are statis-

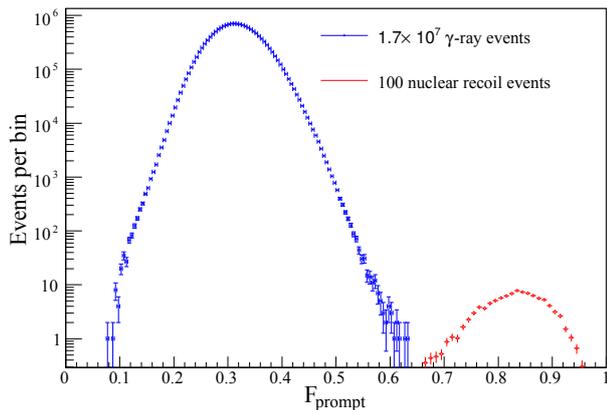


Figure 12: F_{prompt} distribution for 16.7 million tagged γ -ray events from the ^{22}Na calibration between 120 and 240 photoelectrons, i.e. approximately 43–86 keV_{ee} (blue squares). Also shown is the distribution of nuclear recoil events from the Am-Be calibration (γ -ray events from this source are not shown), normalized to the total number of 100 events (red crosses). Bin widths for γ -ray and nuclear recoil event distributions are 0.005 pe and 0.01 pe, respectively. No γ -ray events are seen in the nuclear recoil region.

tical only. We measure the average long time constant of 1.46 ± 0.06 (syst.) μs and 1.38 ± 0.06 (syst.) μs in the surface and the V1720 underground datasets, respectively, consistent with other reported values [12, 18, 19].

The overall increase of the impurity level throughout the run would manifest as the triplet lifetime decrease. We do see a slight trend in the surface run, which is below the absolute systematic accuracy of the measurement, therefore does not affect the uncertainty on the global run average quoted above. It is consistent with the time constant decrease of 0.45 ± 0.07 ns per day. Based on a simple relation

$$F_{\text{prompt}} = \frac{I_1 + \alpha' I_3}{I_1 + I_3}, \quad (4)$$

where $\alpha' = 0.09$ is the fraction of the triplet light measured in the prompt region of the pulse and I_1 and I_3 are singlet and triplet intensities, respectively, the expected mean F_{prompt} shift due to this effect is approximately 2% over 60 days of running and has no consequences for further analysis, as (a) it would not change the number of leakage events in the PSD region of interest (b) in the analytical model a dispersion parameter, b , accounts for this instrumental effect, and (c) we verified that the mean F_{prompt} for electronic and nuclear recoils within each dataset remains stable within $\pm 1\%$ with respect to the global run average and that the PSD cut ($0.7 < F_{\text{prompt}} < 1.0$) corresponds consistently to the nuclear recoil acceptance of not less than 90%.

Light yield reduction caused by the time constant shortening observed in the surface run is not expected to exceed 2%, and can only partially explain the reduction in light yield for that run. The above, together with good triplet lifetime stability in the underground run,

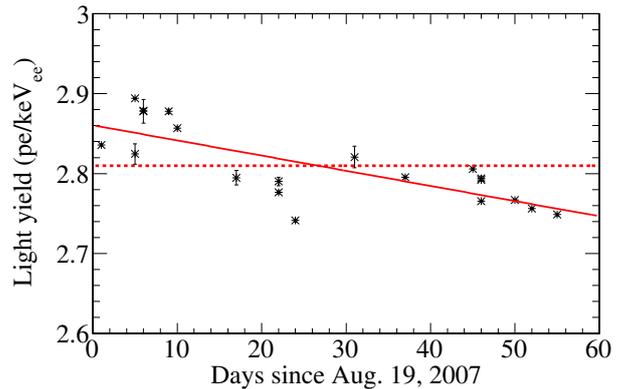


Figure 13: Light yield stability during the surface run. The average light yield is 2.8 ± 0.1 photoelectrons/ keV_{ee} , indicated by the dashed red line. For each point shown are only the statistical uncertainties coming from the fit to the ^{22}Na peak and used to calculate the weighted average. The scatter of the data points is within the systematic uncertainty of the single photoelectron calibration. An indication of a degrading trend equivalent to light yield loss of $(1.9 \pm 0.4) \times 10^{-3}$ photoelectrons/ $\text{keV}_{\text{ee}}/\text{day}$ is seen (red solid line).

suggests additional sources of the light yield reduction, such as the deterioration of detector optics or drifts in the PMT gains, imperfectly corrected for with the single photoelectron charge calibration.

The main purpose of the energy calibration with the ^{22}Na source is determination of the absolute energy window in keV_{ee} , where the limit on pulse-shape discrimination (always derived for the nominal 120–240 photoelectrons region) is valid. The appropriate average light yield value is used for each dataset and, in addition to this, in order to account for the hints of light yield drift, we assign a systematic uncertainty to the absolute energy scale, which reflects the difference in light yield between the beginning and the end of the data taking period.

Thus, for the surface run we establish the position of the absolute energy window as 43–86 keV_{ee} with 4% systematic uncertainty and for the underground run as 44–89 keV_{ee} with 6% systematic uncertainty. When reporting the PSD limit from the combined dataset we will use the energy window position relevant for the underground run, as it conservatively covers both cases.

4.3. High- F_{prompt} backgrounds in the surface run and at SNOLAB

There is a non-zero probability of a random coincidence between genuine nuclear recoils and double-

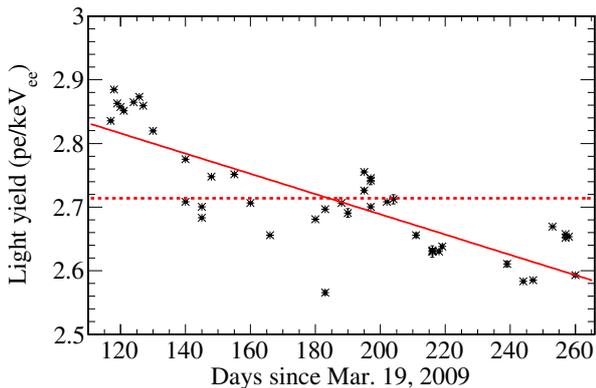


Figure 14: Light yield stability during the run at SNOLAB. The average light yield is 2.7 ± 0.1 photoelectrons/ keV_{ee} , indicated with the dashed red line. For each point shown are only the statistical uncertainties coming from the fit to the ^{22}Na peak and used to calculate the weighted average. The scatter of the data points is within the systematic uncertainty of the single photoelectron calibration. An indication of a degrading trend equivalent to light yield loss of $(1.5 \pm 0.2) \times 10^{-3}$ photoelectrons/ $\text{keV}_{ee}/\text{day}$ is seen (red solid line).

or triple-coincidence tags. A second source of high-prompt backgrounds which are linked to the calibration source will be discussed in Sec. 5.1.4. The nuclear-recoil backgrounds are dominantly coming from alpha decays occurring on the inner detector surfaces (with the nuclear recoils depositing energy in liquid argon and alphas entering the chamber wall) and from alphas scintillating in liquid argon in areas of the detector where the light collection is poor (gaps between acrylic sleeve and windows, neck of the detector). Significant efforts were made to investigate and reduce both types of high- F_{prompt} events, which is discussed in detail in Ref. [32].

High- F_{prompt} backgrounds are evaluated using the DEAP-1 trigger without any calibration sources present. Figure 17 shows the Z_{fit} distribution of high- F_{prompt} background events, compared to that of ^{22}Na calibration γ -ray events. Also shown for reference is the Z_{fit} distribution of high- F_{prompt} background events with the DEAP-1 detector operating underground at SNOLAB. The reduced backgrounds underground allowed a more sensitive measurement of PSD in argon, described in Section 4.4. The average background rate in the region of interest (120–240 photoelectrons) measured for the surface data is 4.6 ± 0.2 mHz, constant throughout the run as shown in Fig. 18. The rate was 1.01 ± 0.1 mHz for the first underground dataset and 0.29 ± 0.04 mHz for the V1720 dataset.

With the triple-coincidence tag, the measurement on surface is limited by random coincidences between the

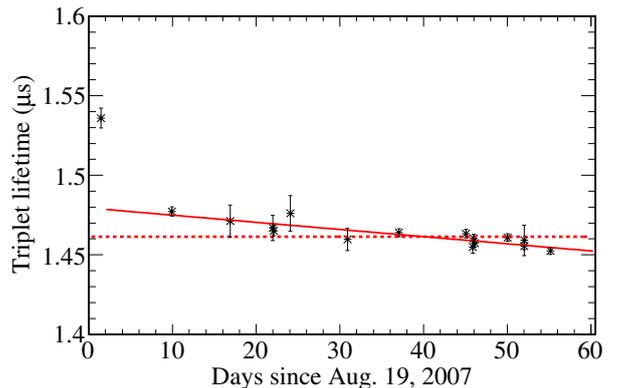


Figure 15: Measured lifetime of the triplet component in liquid argon during the run on surface. Uncertainties shown are statistical only. The averaged long time constant is 1.46 ± 0.06 μs (dashed line). The first data point lies significantly above the average value, which can be attributed to initial instability during the detector start up period. The scatter in the data points is consistent with the systematic uncertainty of the measurement. A slight decreasing trend is seen, corresponding to the time constant decrease of 0.45 ± 0.07 ns per day, if excluding the first data point (solid line).

global tag (back-PMT and annulus) and high- F_{prompt} background events in DEAP-1. The rate of high- F_{prompt} pileup during the γ -ray calibration run is

$$R_{\text{bkg}} = R_{\text{tag}} R_n \Delta t, \quad (5)$$

where R_{tag} is the global tag rate, R_n is the rate of high- F_{prompt} background events measured in DEAP-1 and Δt is the width of the time window from the software data-quality cut.

The achievable PSD can be found by dividing R_{bkg} by the rate of data acquisition in the energy region of interest (ROI), R_{ROI} :

$$D_{\text{bkg}} = \frac{R_{\text{bkg}}}{R_{\text{ROI}}} = \frac{R_{\text{tag}} R_n \Delta t}{R_{\text{ROI}}}. \quad (6)$$

D_{bkg} is thus the discrimination level where we would expect to find one background event. Table 2 shows the relevant parameters and the result from calculating D_{bkg} , and it is below the discrimination level demonstrated in this work.

4.4. Underground run at SNOLAB

After completion of the data runs at surface the detector was reassembled underground at SNOLAB. The data presented here was from two datasets: a smaller set collected in October 2008 and a larger set collected between February and December 2009. The larger set corresponds to the generation 1 detector described in [32].

The high- F_{prompt} background rate in the larger dataset was reduced by a factor of approximately 4.5 in the

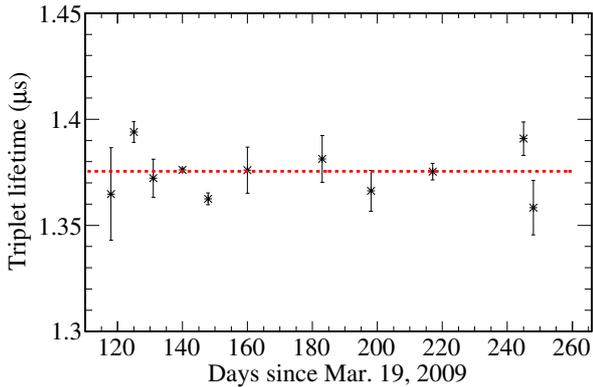


Figure 16: Measured lifetime of the triplet component in liquid argon during the run at SNOLAB. Uncertainties shown are statistical only. The averaged long time constant is $1.38 \pm 0.06 \mu\text{s}$ (dashed line).

Table 2: Background from random coincidence between the global tag and high- F_{prompt} background events in the argon. R_{tag} is the coincidence rate between the annulus and back-PMT with the ^{22}Na source in place (back-PMT rate alone for the underground data), Δt is the coincidence time window imposed by the analysis, R_n is the rate of high- F_{prompt} background events in the liquid argon, R_{ROI} is the rate of triple-coincidence events (double-coincidence for the underground data) and D_{bkg} is the PSD level where one radon-coincidence background event is expected. The numbers for the first underground dataset (labeled UG scope) are approximate in this table as discussed in the text.

Variable	Surface	UG scope	UG V1720
R_{tag} (Hz)	1000	7200	6000
Δt (ns)	60	40	40
R_n (mHz)	4.6	1.01	0.29
R_{ROI} (Hz)	18	74	40
D_{bkg}	1.53×10^{-8}	$\simeq 4 \times 10^{-9}$	1.74×10^{-9}

first underground dataset and a factor of 15 in the second, relative to surface values. This allowed for a more sensitive measurement of PSD in argon. The detector response including light yield for the surface, short underground and long underground datasets were similar.

In the first underground dataset the setup was similar to surface with three exceptions. First, the tag for the ^{22}Na source was only the back PMT and the annulus was not used. Second the ^{22}Na data-taking runs were performed with the PMT waveform sampling frequency varied between 1000, 500 and 250 MHz throughout the dataset. Third, the distance between the tagging PMT and the source was varied within the dataset to optimize signal to noise.

In the large underground dataset the waveform digitization was performed with CAEN V1720 250 MHz waveform digitizers, which allowed to reduce dead time and significantly increase the data taking rate. The V1720 dataset underground was collected with a new inner acrylic detector chamber and new TPB coatings

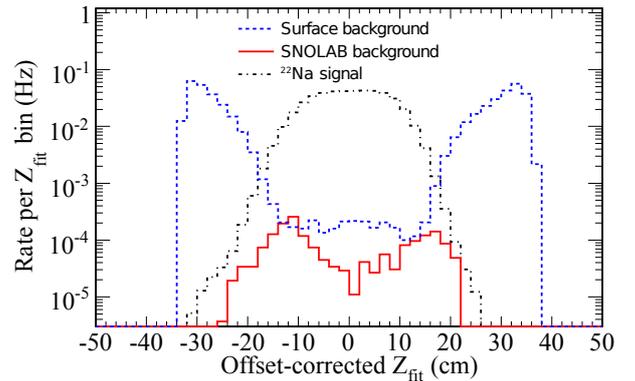


Figure 17: Comparison of Z_{fit} distribution for γ -rays from the ^{22}Na data, and for high- F_{prompt} backgrounds during the surface run (labeled “Surface background”), where the offset between Z_{fit} value and the position in the detector has been subtracted. Also shown, for reference, is the distribution of high- F_{prompt} background events with the detector operating underground at SNO-LAB.

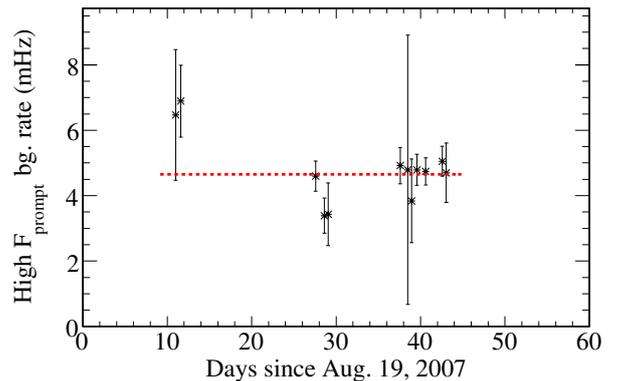


Figure 18: High- F_{prompt} background event rate versus time. The average background rate is 4.6 ± 0.2 mHz.

which reduced background rate.

Because the light yields are similar, the expected PSD response should be the same from 120 to 240 pe. Figure 19 shows the F_{prompt} distribution for representative runs on surface, underground using the original DAQ and underground using the V1720. The distributions look similar, however the V1720 data is shifted by a few per cent towards lower F_{prompt} values. This shift is attributed to different systematic late and prompt pe counting offsets, which are discussed in Sec. 5.1.3. Additionally, about 1% shift can be attributed to improved energy resolution of the detector used for the V1720 run derived from an improved baseline algorithm, which effectively reduces the number of low energy events measured in the region of interest.

The short underground dataset was taken with some variation in data acquisition. It is included in the his-

togram of the combined dataset but it is not used for detailed analysis of the shape of the F_{prompt} distribution in subsequent sections.

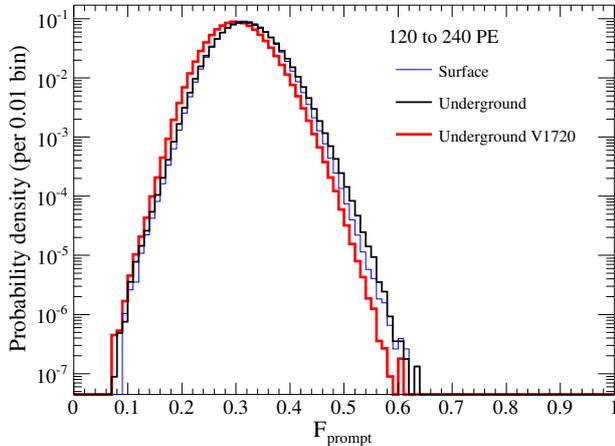


Figure 19: F_{prompt} distribution, normalized to unity, for representative runs on surface (blue line), underground using the original DAQ (black line) and underground using the V1720 (red line).

The PSD cut ($0.7 < F_{\text{prompt}} < 1.0$) for all three runs corresponds consistently to the nuclear recoil acceptance of not less than 90%, which allows us to combine them as below in order to extract the PSD limit. In the next section they will be considered separately for the sake of comparison with the analytic model.

Background runs using the DEAP-1 trigger only were used to measure rates of high- F_{prompt} events between 120 and 240 pe. Based on Eq. (5), from the background and tagging rates one can determine the number of accidental coincidences of high- F_{prompt} events in the data set (see Table 2).

The surface data set comprised 1.7×10^7 events between 120 and 240 pe with an expected pile-up background of 0.26. The first underground data set comprised 2.2×10^7 events with an expected background of 0.07 events. The second underground run with the V1720 digitizers comprised 8.5×10^7 events with an expected background of 0.15 events. These numbers are slightly different than in Table 2 because they account for run-to-run variation in tagging and trigger rates within the datasets. Thus the total expected pile-up background is 0.48 events and the probability of obtaining one or more pile-up events is 38%. The entire PSD data set at ~ 2.7 pe/keV (surface and underground) is shown in Fig. 20 and Fig. 21. There is one event at high F_{prompt} , which is consistent with random pile-up with a background event (such as a nuclear recoil coming from a decay on the detector surface, or a degraded alpha).

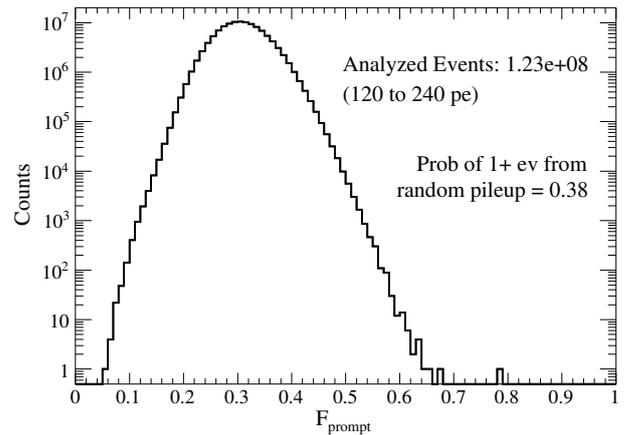


Figure 20: The combined PSD data set from surface and underground runs at ~ 2.7 pe/keV.

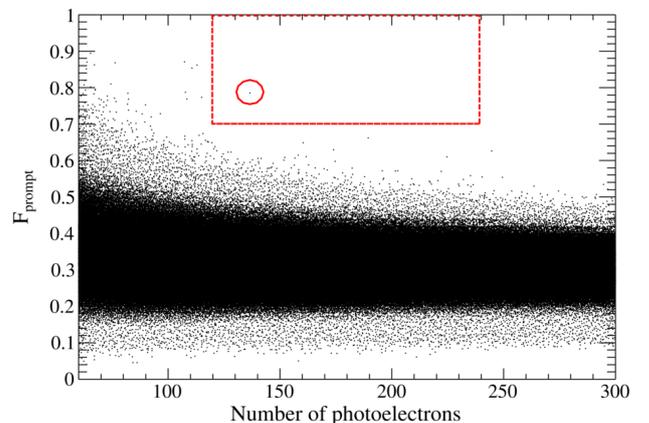


Figure 21: F_{prompt} versus energy distribution for the combined PSD data set containing triple- and double- coincidence γ -ray events, in surface and underground runs, respectively, at ~ 2.7 pe/keV. The region between 120–240 photoelectrons for $F_{\text{prompt}} > 0.7$ contains one contamination event, marked with a red circle.

The above values are used together with the background expectations to evaluate 90% C.L. upper limits assuming the number of measured leakage events is Poisson distributed (using a standard method described in Ref. [34]). The results relevant for 90% nuclear recoil acceptance ($0.7 < F_{\text{prompt}} < 1.0$) are: $< 1.4 \times 10^{-7}$ and $< 3.3 \times 10^{-8}$ for surface and underground runs, respectively, or $< 2.7 \times 10^{-8}$ for both runs taken together. While this result is based on ^{22}Na calibration, no significant difference in PSD power is expected for ^{39}Ar β events (see Sec. 5.4).

5. Analytic model for discrimination power

We developed a model that describes the probability $R(f; N_{pe})$ to find F_{prompt} value f at TotalPE N_{pe} ,

outlined in Appendix A through Appendix C.

The model takes as inputs the probability distributions for the number of prompt and the number of late PE detected in response to an interaction with a particle of a given energy. For our dataset, we use beta-binomial distributions as per Eq. (A.13), convolved with a Gaussian.

The beta-binomial distribution is a binomial distribution where the binomial probability p is itself a random variable distributed as the beta distribution. Another way to interpret this is that the mean of the binomial distribution governing how many prompt or late PE are recorded for an event is not fixed, but picked randomly from a beta distribution for each event. The binomial probability in this case is the probability to turn a photon emitted in the interaction into a photoelectron, or in other words to detect it. The expectation value for p must be $\bar{p} \simeq 2.7/40$ - the detector light yield divided by the photon yield in argon. By randomly varying p as a beta distribution we account for changes in the light detection probability with event position and with time. Since in DEAP-1 the detection probability is so small, this step dominates the distribution over the original binomial distribution of the number of prompt and late photons emitted. We refer the reader to Appendix A.4 for further discussion of this distribution.

The Gaussian distribution convolved into the beta-binomial models the noise affecting the PE-counts in the prompt and late windows due to the read-out electronics and uncertainty in the SPE charge calibration, with the combined standard deviations of $\sigma_{es,p}$ or $\sigma_{es,l}$. The final form of the uncorrelated prompt-PE and late-PE distributions is then

$$P_E(n_p) = \sum_{n'=0}^{\infty} \text{BetaBin}(n'; \mu_p, \bar{p}, b) \times \frac{1}{\sqrt{2\pi}\sigma_{es,p}} e^{-\frac{1}{2}\left(\frac{n'-n_p}{\sigma_{es,p}}\right)^2} \quad (7)$$

$$L_E(n_l) = \sum_{n'=0}^{\infty} \text{BetaBin}(n'; \mu_l, \bar{p}, b) \times \frac{1}{\sqrt{2\pi}\sigma_{es,l}} e^{-\frac{1}{2}\left(\frac{n'-n_l}{\sigma_{es,l}}\right)^2} \quad (8)$$

where μ_p and μ_l are the mean values of the uncorrelated distributions and b is a shape parameter (a measure of the dispersion beyond the pure binomial case).

The total variances of these distributions are, using Eq. (A.14):

$$\sigma_p^2 = \sigma_{es,p}^2 + (1 + 1/b)\mu_p \quad (9)$$

$$\sigma_l^2 = \sigma_{es,l}^2 + (1 + 1/b)\mu_l \quad (10)$$

From these uncorrelated distributions, we build the conditional distribution to have n_p prompt PE given the event has N_{pe} TotalPE, for events of energy E :

$$P'_E(n_p; N_{pe}) = P_E(n_p) \cdot L_E(N_{pe} - n_p) \quad (11)$$

Since our calibration source is not mono-energetic, we build the sum over all energies, Eq. (A.10), where we approximate the probability to detect an event of energy E at N_{pe} TotalPE, $T_E(N_{pe})$, as a Gaussian with width

$$\sigma_t^2 = \sigma_p^2 + \sigma_l^2 \quad (12)$$

and mean

$$\mu_t = \mu_p + \mu_l = E \cdot Y \quad (13)$$

where Y the light yield.

Window noise of width σ_w is folded into the distribution as explained in Appendix A.4.2.

The conditional distribution for n_p prompt PE is then

$$P'(n_p; N_{pe}) = \sum_{n'_p=0}^{\infty} \sum_{\mu_t=0}^{\infty} P'_E(n'_p; N_{pe}) \cdot N(\mu_t) \times \frac{1}{\sqrt{2\pi}\sigma_t} e^{-\frac{1}{2}\left(\frac{N_{pe}-\mu_t}{\sigma_t}\right)^2} \frac{1}{\sqrt{2\pi}\sigma_w} e^{-\frac{1}{2}\left(\frac{n'_p-n_p}{\sigma_w}\right)^2} \quad (14)$$

Eq. (14) is turned into a distribution for the F_{prompt} variable by variable transformation $n_p = f \cdot N_{pe}$:

$$R(f; N_{pe}) = N_{pe} \cdot P'(n_p = f \cdot N_{pe}; N_{pe}) \quad (15)$$

It is a function of the means μ_p, μ_l and widths σ_p, σ_l of the uncorrelated prompt-PE and late-PE distributions, modified by the energy spectrum of the source and by window noise.

5.1. Comparison with data

The model from Sec. 5 was fit to the F_{prompt} vs TotalPE histogram (Fig. 10) for the underground and surface data sets. Due to the large computational resources required to perform the 2D fit over all TotalPE bins, 12 1-PE wide slices every 20 PE, from 60 to 280 PE, were selected from the 2D distribution and the 2D fit included only those slices. In addition to the 8 overall fit parameters, each TotalPE slice has an individual normalization parameter in the fit. To describe the F_{prompt} distribution for a range of TotalPE bins, the distributions of the individual TotalPE bins in the range were added together, where the normalization parameter for each bin was taken from the bin in the range that was included in the fit.

The start values and parameter ranges of the fit were determined using further instrumental inputs and constraints described in this section.

5.1.1. Noise terms and energy resolution

The uncertainty in the counting window of approximately 30 ns leads to an uncertainty in the late photoelectron count of up to $\epsilon_{\text{win}} = 2.5\%$, hence in Eq. (11) $\sigma_{\text{win}} \leq 0.025 \cdot \mu_t(1 - \bar{F}_p)$.

The detector hardware's non-uniformity contribution, b from Eq. (7), is unconstrained.

The SPE noise contribution for 1 PE is estimated to be $\epsilon_{\text{spe}} = 0.34$ from the SPE histogram shown in Fig. 6 by fitting a Gaussian to the SPE spectrum and taking $\epsilon_{\text{spe}} = \sigma_{\text{spe}}^P / \mu_{\text{spe}}^P$. It goes with the measured number of photoelectrons such that $\sigma_{\text{spe}}^2 = \epsilon_{\text{spe}}^2 \cdot N_{pe}$.

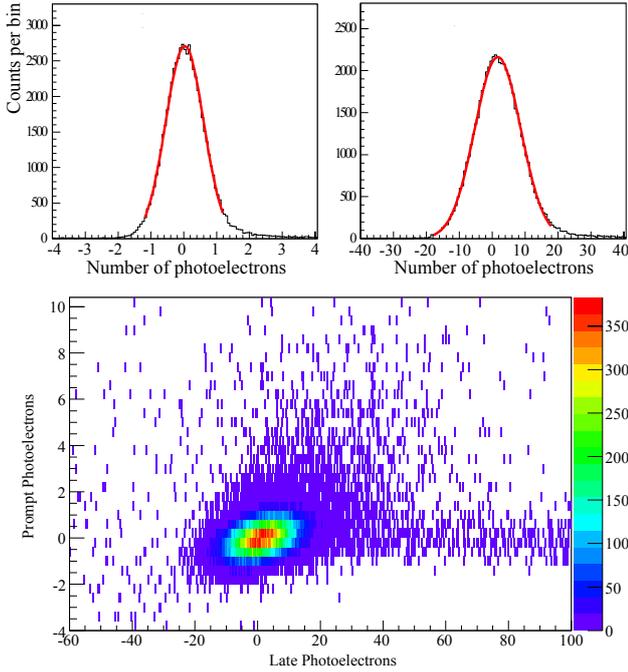


Figure 22: Prompt (top left panel) and late (top right panel) electronic noise components from a run triggered with a random pulser, each fit with a Gaussian function (red line), with 0.07 PE and 0.7 PE wide bins, respectively. These contributions are representative of the noise generated by the hardware electronics and analysis algorithms. The late light, integrated over a 10 μ s window is more susceptible to electronic noise than the short prompt window. Prompt and late electronic noise components are correlated (bottom panel).

Electronic noise of $\sigma_{\text{elec,p}}=0.58$ photoelectrons in the prompt window and $\sigma_{\text{elec,l}}=7.0$ photoelectrons in the late window are measured by triggering the detector with an external pulse generator and analyzing the PMT traces, as shown in Fig. 22. Both noise contributions are significantly correlated (with correlation factor of $\rho_{\text{elec}}^{LP} \approx 0.5$). The correlation in the noise introduces a small correlation between P_E and L_E , which is disregarded. Since this correlation is positive and generally moves events between TotalPE bins, it is not of the same quality as the window noise and cannot be treated in the same framework.

In the V1720 underground dataset, an additional zero-suppression step was used in order to remove periodic low-amplitude noise picked up by the electronics and not seen in the previous dataset. The zero-suppression algorithm also significantly suppressed electronic noise in general, however, a discontinuous profile of the residual noise does not translate into a meaningful measurement of σ_{elec} to use as the analytic model input and benchmark against ^{22}Na data.

The electronic and SPE noise add up to the noise in Eqs. (7) and (8)

$$\sigma_{es}^2 = \sigma_{\text{elec}}^2 + \sigma_{\text{spe}}^2 \quad (16)$$

and the total variance of these distributions is then

$$\sigma^2 = \sigma_{\text{BetaBin}}^2 + \sigma_{\text{spe}}^2 + \sigma_{\text{elec}}^2 \quad (17)$$

or written out

$$\sigma_p^2 = (1 + 1/b + \epsilon_{\text{spe}}^2) \bar{F}_p \mu_t + \sigma_{\text{elec,p}}^2 \quad (18)$$

$$\sigma_l^2 = (1 + 1/b + \epsilon_{\text{spe}}^2) (1 - \bar{F}_p) \mu_t + \sigma_{\text{elec,l}}^2 \quad (19)$$

where we made use of Eq. (A.14).

The energy resolution function employed in the model is composed from the prompt and late noise as shown in Eq. (12).

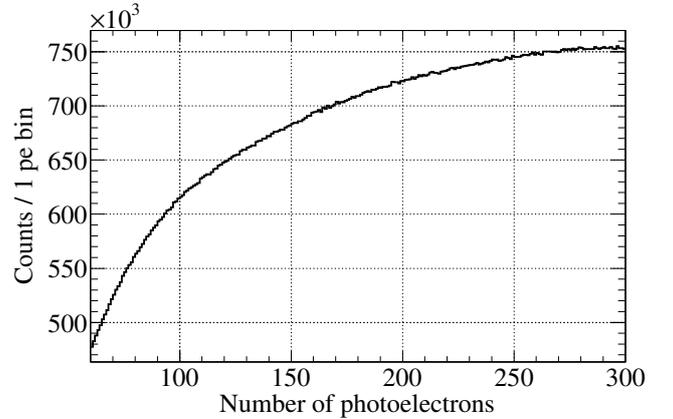


Figure 23: Energy spectrum from the ^{22}Na dataset taken at SNO-LAB with V1720.

5.1.2. Energy spectrum

The measured spectrum over the energy scales of interest is shown in Fig. 23. The simulated spectrum of raw energy deposit in the detector from ^{22}Na calibration source gammas is to a good approximation flat over the 120–240 photoelectron region. The measured spectrum varies by only about 13% for events of 120–240 photoelectrons, though is heavily dependent at lower energies. This is partially due to a large fraction of low energy events not passing the data cleaning cuts [21].

A flat spectrum was used in the model Eq. (14). The systematic difference introduced in this step was determined by comparing the analytic model results when using the empirical and when using the flat spectrum for $N(E)$ and found to be negligible, see Sec. 5.4.

5.1.3. Systematic PE counting error

We observe an upturn of the mean of the F_{prompt} distribution for electron-recoil events toward lower TotalPE, as seen in Fig. 11. This upturn can be explained by a number of effects including: argon scintillation physics, a Prompt PE-dependent trigger efficiency, or a systematic error in PE counting. We built models for each of these three effects and found that the model where all of the observed upturn is accounted for by a systematic mistake in counting the number of prompt and the number of late PE describes our data best. We however include the model where the upturn is due to argon scintillation physics for comparison in Fig. 34.

The systematic counting error hypothesis is motivated by the behaviour of the means, μ'_p and μ'_l , of the conditional prompt-PE and late-PE distributions¹⁰, which as shown in Fig. 24 is linear between 50 and 300 PE with a non-zero x-axis intercept. This is expected from a model, detailed in Appendix C, in which the observed number of prompt and late PE are equal to a true number plus an offset¹¹, while the true underlying mean of the F_{prompt} distribution is constant with energy.

The systematic over-counting hypothesis is further cross-checked by studying how the variances of the correlated distributions behave with the distribution mean and with TotalPE, shown in Fig. 25 overlaid with the model prediction from Eq. (C.17). A Gaussian approximation to the uncorrelated distributions is used and no energy convolution was applied except in the top panel of Fig. 25. This explains some of the observed discrepancy with the model. We also tried to describe the TotalPE-dependence of the distributions' variances using a general polynomial noise function, while assuming the measured values of prompt and late PE, and thus TotalPE, are correct. This function required an unphysical negative noise value for at least one of the polynomial terms to adequately fit the data, indicating that the data is significantly influenced by an instrumental effect. The over-counting model fits the observed variances without any unphysical noise terms.

The model lines are drawn with the same parameters used to describe the F_{prompt} distributions and summa-

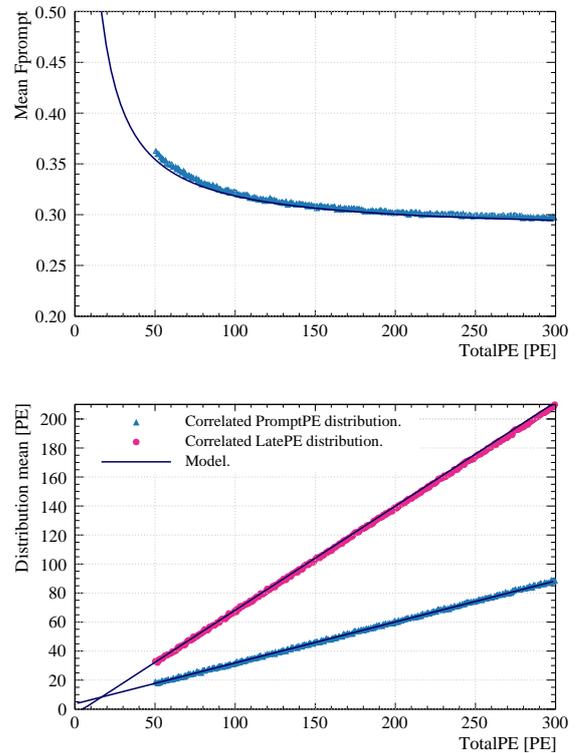


Figure 24: The mean of the F_{prompt} distribution (top) and means of the prompt-PE and late-PE distributions (bottom) in each bin of TotalPE (V1720 data). The expectation based on model parameters used to describe the F_{prompt} distribution, using Gaussian approximations and without convolution over energy, is drawn as a solid line.

¹⁰The correlated distributions, Eq. 14 for prompt and equivalent equation for late-PE, are what is directly measured in the experiment, and thus their means can be directly calculated from the data. For Gaussian free parent distributions, the relation between the means of the correlated and free distributions is calculated in Appendix B.

¹¹We assume the SPE charge calibration is correct and include the possibility that it is slightly wrong as a systematic uncertainty in the model, so it is not considered here.

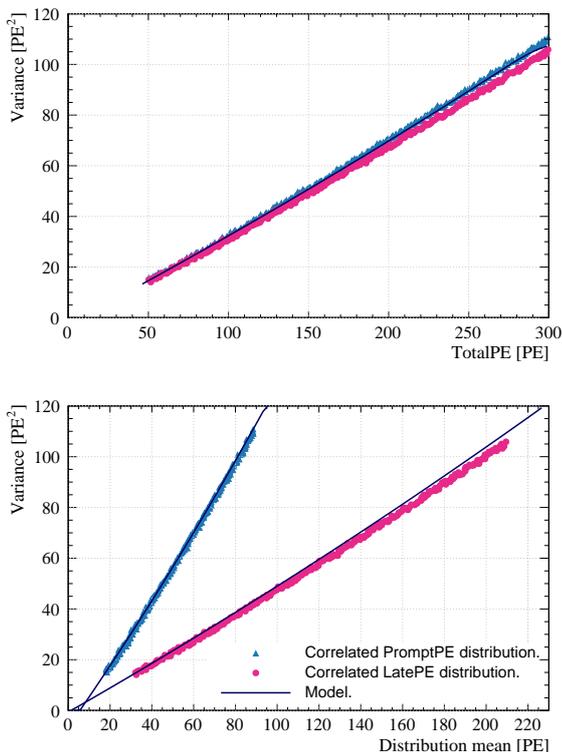


Figure 25: The variances of the prompt-PE and late-PE distributions in each bin of TotalPE (top) and versus the mean of the distribution (bottom). The expectation based on model parameters used to describe the F_{prompt} distribution, using Gaussian approximations, is drawn as a solid line. The top plot includes the effect of a convolution over the energy spectrum.

rized in Tab. 3, and are consistent with our data. We henceforth assume that in the energy range of interest here, the true mean F_{prompt} is a constant, while the observed mean F_{prompt} has a TotalPE-dependent bias due to a systematic counting error in the number of prompt and late PE.

5.1.4. Pileup and ^{22}Na induced backgrounds

In Sections 4.3 and 4.4 the probabilities of random coincidences between the global tag and high- F_{prompt} ROI events in argon were discussed for both runs. Also present in the data are prompt events with energies lower than ~ 60 PE, which originate mainly from Čerenkov emission in PMT glass and lightguide acrylic, dark noise and, potentially, from discharges in the PMTs.

Random coincidences of genuinely tagged ^{22}Na events with such low energy events add extra photoelectrons to the signal in one or both PMTs, can pass the basic cuts, and can measurably affect the low- F_{prompt} tail of the F_{prompt} distribution. This effect is not included in the analytic model and can lead to discrepancies with the data at lower F_{prompt} values. It is negligible in the high- F_{prompt} tail.

The 1.27 MeV γ from the ^{22}Na source itself can Compton scatter in acrylic or glass creating prompt Čerenkov light simultaneous with genuine γ -induced scintillation event in liquid argon, effectively shifting the event towards higher F_{prompt} values. This has negligible effect on the low- F_{prompt} tail, but can influence the leakage probability at higher F_{prompt} values.

A two-stage simulation was used to compute the effect on the F_{prompt} distribution due to the radioactive source-related coincidences. The first stage was a simulation of ^{22}Na decays in a realistic Geant4 model of DEAP-1, which included the NaI crystal used for tagging, shielding configuration, as well as all details of the detector itself, in particular the wavelength-dependent optical attenuation of UVA acrylic, measured ex-situ¹². From this simulation, the spectrum of those Čerenkov events was produced which occur in coincidence with tagged events of 120–240 PE that still pass data selection cuts. Deposition of approximately 511 keV energy in NaI was set as the tagging criterion, consistent with discriminator settings in the experiment.

The second stage was a fast toy Monte Carlo with logic equivalent to that of the analytic model, i.e. using the model spectrum and beta binomial probability distributions to draw numbers of detected prompt and late PE¹³ and then smearing them with respective

¹²This effect was first recognized in a later DEAP-1 detector generation which was built using UV-transmitting acrylic so that the Čerenkov light yield was increased [35, 36] and the effect therefore more apparent.

¹³A more elaborate scintillation model taking into account partition of deposited energy between excitation and ionization quanta and recombination was also tried, following the approach used in NEST [37]. It agreed with the simpler model inside of the parameter space explored in this work.

Gaussian noise terms, parameterized as in Tab. 3. PE counts were then randomly generated with the Čerenkov spectrum from the first step and added to the number of detected prompt PE.

Simulation results are compared with the data in the next section.

5.2. Results

The model parameters that best describe both the behaviour of the prompt-PE and late-PE distribution means and variances as well as the F_{prompt} distribution versus TotalPE, are summarized in Tab. 3, together with their expected ranges from independent measurements. The $\sigma_{\text{elec,p}}$ was kept fixed at 0.57 PE (surface) or 0.5 PE (underground) since a small change here has little effect and numerical stability of the model was better that way. The SPE calibration was also fixed in the fit. For the V1720 dataset the systematic effect of varying the SPE calibration in the fit was studied, and the maximum resulting change to the fit parameters is quoted in brackets.

	Surface		Underground	
	Fit	Expected	Fit	Expected
\bar{F}_p	0.300	–	0.282 (+0.001)	–
δ_p [PE]	6.1	–	6.57 (+0.2)	6.0–7.0
δ_l [PE]	5.3	–	3.96 ($^{+1.3}_{-0.2}$)	2.0–3.8
ϵ_{spe}	0.26	0.34	0.25 (+0.14)	0.34
ϵ_{win}	0.016	<0.025	0.016 (-0.008)	<0.025
$\sigma_{\text{elec,p}}$ [PE]	0.57	0.57	0.5	<0.57
$\sigma_{\text{elec,l}}$ [PE]	6.6	<7.0	2.26(-0.7)	<7.0
b	1.86	–	1.65 ($^{+0.25}_{-0.35}$)	–

Table 3: Fit results and independent measurement expectation for the surface and underground F_{prompt} versus TotalPE data. Numbers in brackets are the maximum amount of systematic shift that comes with changing the SPE calibration by $\pm 10\%$.

The model overlaid on the data is shown in Figs. 26 and 28 for the TotalPE region 60–120 photoelectrons, and in Figs. 27 and 29 for the TotalPE region 120–240 photoelectrons, for the surface and V1720 underground datasets respectively. Fig. 30 shows the model and data in 10 PE bins between 60 and 270 PE for the underground dataset.

The analytic model describes the measured F_{prompt} versus TotalPE distribution from 60 to 280 photoelectrons and 0.28 to 1.0 F_{prompt} with reduced χ^2 of 3.1

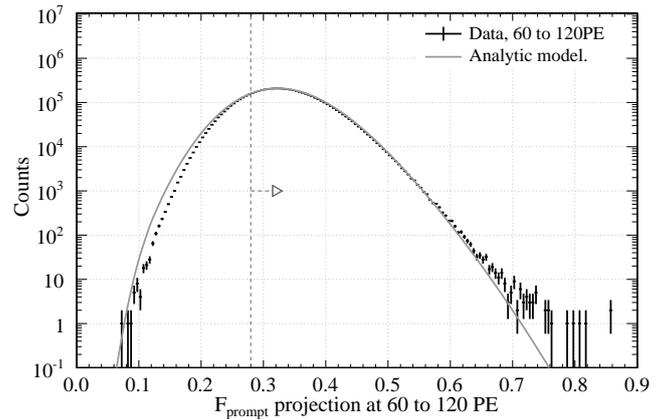


Figure 26: Comparison of the surface run data and the analytic model in the region 60–120 photoelectrons (approximately 21–43 keV_{ee}). Dashed vertical line with an arrow indicates the fit range.

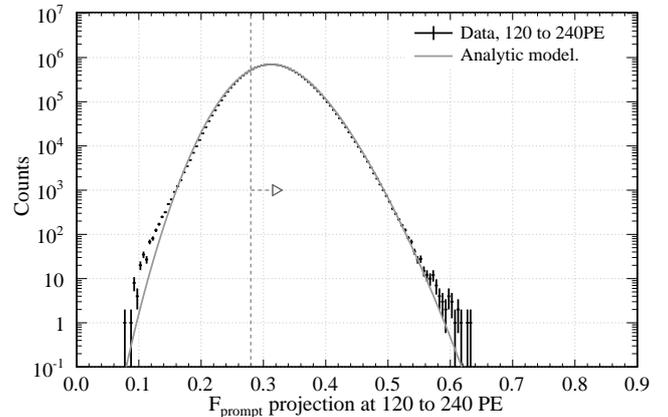


Figure 27: Comparison of the surface run data and the analytic model in the region 120–240 photoelectrons (approximately 43–86 keV_{ee}). Dashed vertical line with an arrow indicates the fit range.

(surface) and 2.0 (underground) for a fit performed as explained in Sect. 5.1.

The region below F_{prompt} of 0.28 was excluded from the fit. The distribution in this region is affected by cut and trigger efficiencies, as well as pileup. At lower energies, as in Figures 26 and 28, this may remove events with comparatively low number of photoelectrons in the prompt window or add additional pileup events, with non-trivial dependence on run conditions (such as background rate and spectrum) as well as on cuts. As this was not studied in detail, it is not clear which of the two effects should dominate. At higher energies, the effect of pileup with low energy backgrounds adds additional events below F_{prompt} of 0.28. It is noticeable around 0.1 F_{prompt} above 180 PE in Fig. 30, where the PSD distribution is narrow enough that the additional events separate out clearly. This low- F_{prompt} region is

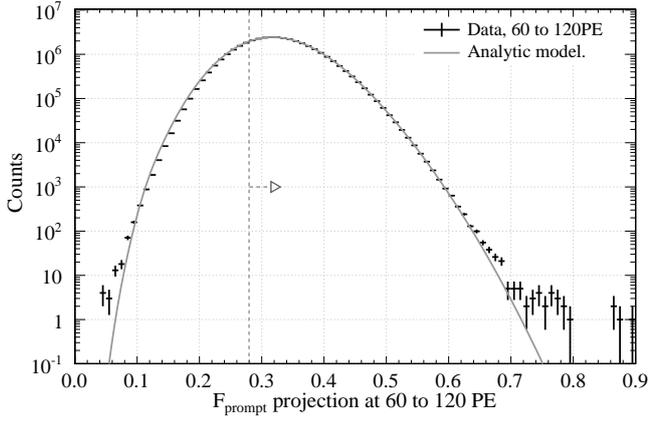


Figure 28: Comparison of the SNOLAB V1720 data and the analytic model in the region 60–120 photoelectrons (approximately 22–44 keV_{ee}). Dashed vertical line with an arrow indicates the fit range.

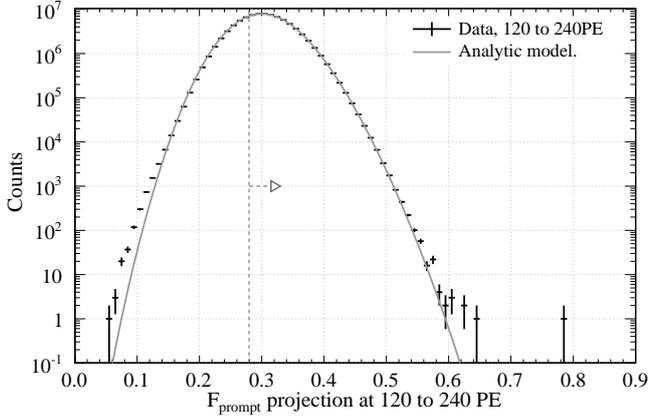


Figure 29: Comparison of the SNOLAB V1720 data and the analytic model in the region 120–240 photoelectrons (approximately 44–89 keV_{ee}). Dashed vertical line with an arrow indicates the fit range.

not further studied as the position of the distribution peak and the high- F_{prompt} tail are the relevant measures for determining the leakage into the nuclear-recoil region.

The fit between model and data is not equally good in all energy bins. The individual p-values above 0.28 F_{prompt} for a number of 1 PE wide TotalPE bins are shown in Tab. 4 for the V1720 underground dataset. The model does not account for coincidences from events caused by the ^{22}Na source, so it is not expected to match the data perfectly. The model adequately describes the data in the region of interest 120–240 PE, and diverges toward lower and higher TotalPE. The region below about 100 PE is very sensitive to effects from photoelectron counting errors and to the event energy spectrum, and the region above 200 PE is very sensitive to the absolute value of the noise terms, which are

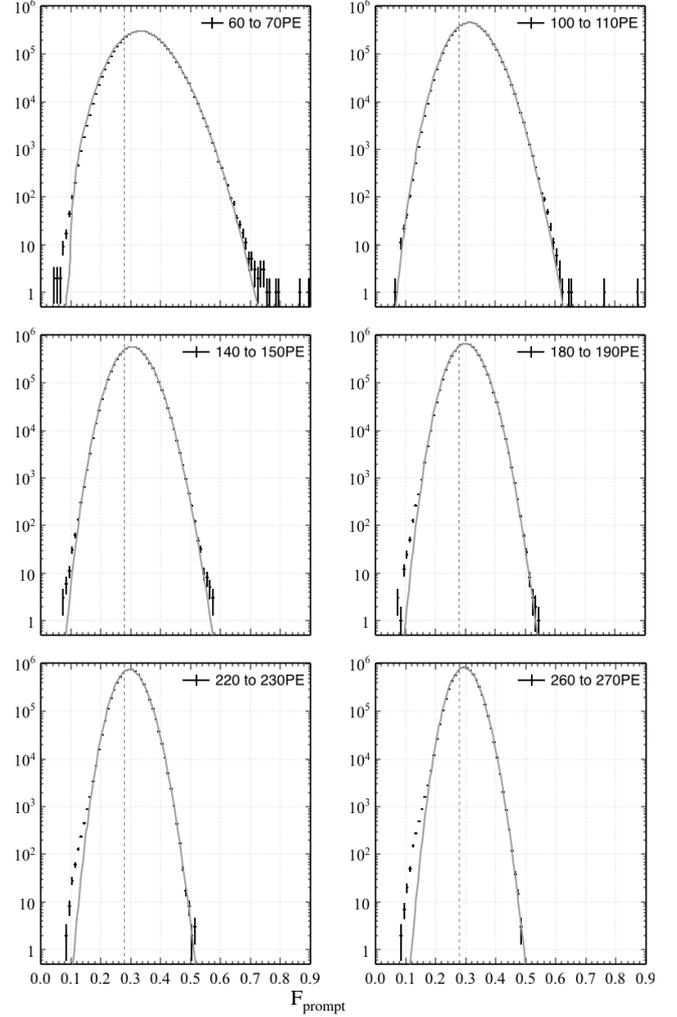


Figure 30: The F_{prompt} distribution from the underground run data shown separately for each of six energy bins, as indicated on the plots. Dashed vertical lines indicate the lower limit of the fit range.

strongly correlated with the photoelectron counting error at lower PE. The noise contributions as a function of TotalPE are parametrized in the noise model which may not be adequate anymore at these PE ranges.

Despite fair p-values for individual TotalPE bins inside of the 120–240 PE region, when all these bins are stacked together there is a clear excess of events above $F_{\text{prompt}}=0.58$, which is visible in Fig. 29. In Sec. 5.1.4 a Čerenkov type background was discussed, which, as shown below, included in a simulation reproduces this excess. Because of computational complexity the Čerenkov contribution was not included in the analytic model and could not be used for fitting.

To represent the discrimination power graphically, we

Table 4: Model match above $0.28 F_{\text{prompt}}$ in individual 1 PE wide bins for the V1720 underground dataset (see text).

TotalPE bin	p-value
60	2×10^{-18}
80	4×10^{-4}
100	2×10^{-5}
120	6×10^{-4}
140	0.02
160	0.23
180	0.02
200	0.16
220	0.02
240	5×10^{-4}
260	1×10^{-4}
280	4×10^{-8}

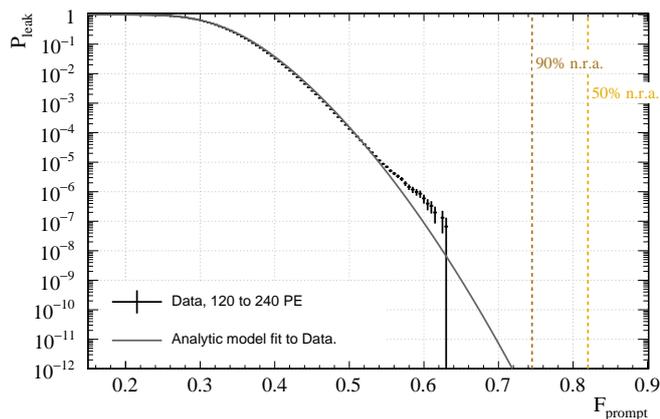


Figure 31: P_{leak} distributions from ^{22}Na calibration data from DEAP-1 on surface with analytic model fit. Also indicated are F_{prompt} values for 50% and 90% nuclear recoil acceptances (brown and orange dashed lines). Nuclear recoil acceptances (n.r.a.) are determined from neutron calibration data.

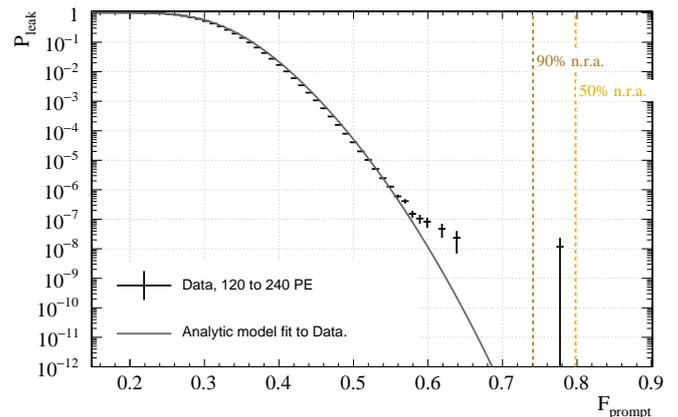


Figure 32: P_{leak} distributions from ^{22}Na calibration data from DEAP-1 underground at SNOLAB (V1720 data) with analytic model fit. Also indicated are F_{prompt} values for 50% and 90% nuclear recoil acceptances (brown and orange dashed lines). Nuclear recoil acceptances are determined from neutron calibration data.

define the variable P_{leak} as

$$P_{\text{leak}}(f') = \frac{\int_{f'}^1 F_{\text{prompt}}(f) df}{\int_0^1 F_{\text{prompt}}(f) df} \quad (20)$$

for a given F_{prompt} distribution. The value of P_{leak} for a given F_{prompt} value thus represents the pulse-shape discrimination. Figures 31 and 32 show the P_{leak} distributions derived from the ^{22}Na calibration data (the same data shown in Figures 27 and 29), along with the predictions from the analytic PSD model. Also shown are reference acceptances for nuclear recoil events estimated directly from neutron calibration data as shown in Fig. 11 for the surface dataset.

The result of the Monte Carlo simulation including Čerenkov emission induced by ^{22}Na gammas (see Sec. 5.1.4) is shown in Fig. 33 for parameters chosen for the underground dataset, overlaid with the data. The simulation reproduces the measured distribution including the excess in the high- F_{prompt} tail.

5.3. Discussion

Considering the systematic uncertainties in the photoelectron counting, both due to the offsets and possible scaling of up to 10%, and considering that effects such as trigger efficiency and pileup are not included in the model, the model describes the data reasonably well, especially when considering the region above around $0.28 F_{\text{prompt}}$ which is no longer effected by trigger efficiency and pileup with low-energy events, and when including the effect from pileup with source induced Čerenkov events through Monte Carlo simulation.

Fig. 33 shows that after accounting for Čerenkov light induced by gammas from the ^{22}Na source, the deviation of the leakage probability from the analytic PSD

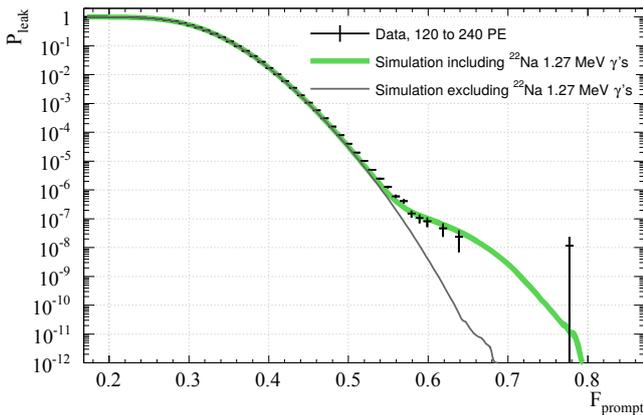


Figure 33: Leakage probability for simulated electromagnetic interactions. Prompt and late PE are drawn from distributions mimicking the analytic model discussed, including all sources of noise, with parameter values from the underground dataset (grey). In the second simulation (green), PMT counts are additionally drawn from a spectrum of high F_{prompt} Čerenkov events, which was generated with a full Geant4 simulation of the detector. This results in an increased leakage probability above a certain F_{prompt} , as observed in the data. Simulated curves have the statistics of ~ 1 at 10^{-12} . Based on the simulated spectrum we expect 1.9 events above $F_{\text{prompt}}=0.65$, while no events are observed (excluding the outlier at $F_{\text{prompt}}\simeq 0.78$, which is most likely unrelated to 1.27 MeV γ 's, as explained in Sec. 4.4). The probability of such an occurrence is 15%.

model above $0.55 F_{\text{prompt}}$ is in agreement with the measurement from Fig. 32.

The noise terms from the analytic model must add up to the total energy resolution. The total energy resolution was measured near the 59.5 keV peak from the Am-Be source to be $\sigma_t = 11.1$ keV (surface) and $\sigma_t = 8.8$ keV (underground). As per Eqs. (12), (18), and (19), the model resolution is about $\sigma_t = 6.7$ keV (surface) and $\sigma_t = 6.5$ keV (underground). From a full Monte Carlo simulation of the detector response in the underground configuration, we expect a $\sim 25\%$ discrepancy between the measured resolution and the model resolution because the calibration source full energy peak in the liquid argon has a small low-energy tail component from gammas which reach the target with energies already degraded via Compton scattering in the detector materials. Smearing the raw energy deposit spectrum obtained from a Geant4 simulation of DEAP-1 Am-Be and ^{22}Na calibration runs with the energy resolution from the analytic model gives the overall full energy peak widths consistent with the data for the underground dataset. Since the parameters for this dataset will be used for extrapolations, we did not in detail study the additional discrepancy for the surface dataset.

In our model, we describe the upturn of the mean F_{prompt} value at lower energies, in the energy range under consideration here, by an instrumental effect, namely a systematic over-counting of the number of PE in the

prompt and late windows. This upturn has been seen in many experiments [4, 19, 38] and the cause may not be the same each time. We for example note that the measurement in [38] shows an essentially flat mean F_{prompt} in the energy range considered in this work, as assumed in our model. It is likely that the mean F_{prompt} for electromagnetic events truly increases toward lower energies due to the underlying scintillation physics, at energies below what is considered in this work. The discrepancy between the model line and the data in Fig. 24 (top) hints at such a true change in the mean F_{prompt} value below about 80 PE.

The reason for the systematic over-counting of prompt and late PE is currently not well understood. A possible mechanism is trigger-induced cross-talk on the electronics, which would effectively shift the baseline for a certain amount of time and due to our simple baseline algorithm and charge-based PE counting, this adds a fixed amount of charge to both the prompt and the late window, with more charge added in the prompt window as it is closer to the trigger time. Dark noise and after-pulsing also add extra counts, though preferentially in the late window.

The relatively big change in the F_{prompt} distribution mean from comparatively small errors in the PE count highlights the need to carefully understand the behaviour of the electronics, including the baseline and the trigger efficiency, and to count PEs accurately in a future experiment, especially toward lower energies. We also note that a prompt PE-dependent trigger efficiency can introduce a significant energy-dependent bias in the mean and width of the measured F_{prompt} distributions, especially at lower energies. This effect when modelled did not describe our data as well as the PE-shift, but may also add to the discrepancy between the data and the model curve in Fig. 24 (top).

5.4. Systematic uncertainties

We estimate how systematic uncertainties on input parameters of the analytic model affect the predicted discrimination power by calculating the P_{leak} distributions

- With flat and with measured energy spectrum.
- With the mean SPE charge increased or decreased by 10%.
- Using a running mean F_{prompt} and assuming no counting error in the number of prompt and late PE.

Fig. 34 shows the curves for model parameters from Fig. 32 and with the above three parameters changed. The dominant systematic uncertainty is due to the uncertainty in the SPE charge calibration. The uncertainty due to the over-counting of charge slightly smaller than that from the SPE charge calibration, and it is

over-estimated since no further fits were performed to try and adjust the noise parameters for a better fit.

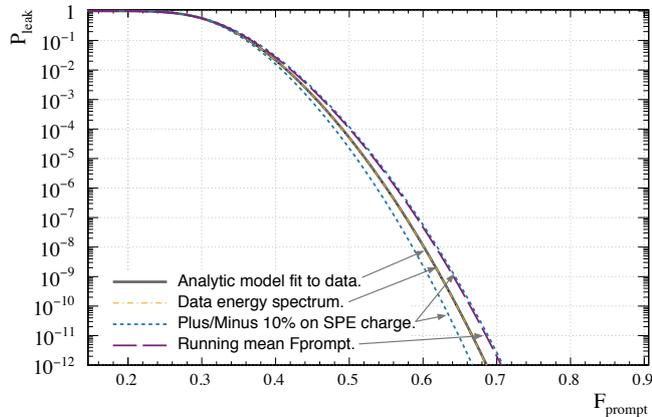


Figure 34: Systematic uncertainties on the model P_{leak} distribution from Fig. 32, for V1720 data taken at SNOLAB (gray bold line). Drawn in orange dash-dot and indistinguishable from the former is the model using the measured energy spectrum in the convolution. The blue dotted lines show uncertainty due to 10% shift in the spe charge calibration when keeping all other model parameters the same. The purple dash-dot line is drawn using the same parameter values as the nominal model (grey line) but no prompt or late offset, and a running mean F_{prompt} value, behaving as shown Fig. 24 top, instead.

At $0.65 F_{\text{prompt}}$ these systematic effects change the leakage probability by about an order of magnitude in either direction.

6. Dark Matter Sensitivity of a Tonne-Scale Detector

In the previous section we demonstrated that the analytic model based on Eq. (14) adequately describes the data from the DEAP-1 detector in the region of F_{prompt} relevant for leakage of electromagnetic events into the nuclear recoil region, after adding source-induced pileup effects by Monte Carlo simulation.

Using the model but not the source-induced pileup contribution, we next estimate the expected discrimination power in liquid argon versus energy threshold assuming a large target mass detector. We have designed DEAP-3600, a large spherical detector consisting of 255 PMTs surrounding a spherical target with a mass of 3600 kg of liquid argon [39]. Geant4 simulations benchmarked against the light yield in the DEAP-1 detector predict that in this geometry a light yield of approximately 8 PE/keV_{ee} could be achieved. Assuming the detector is constructed of clean materials and appropriately shielded so that genuine nuclear recoil backgrounds have been mitigated, the dominant detector background in argon will be from β decays of ^{39}Ar . Argon that is condensed from the atmosphere is known to

contain cosmogenically-produced ^{39}Ar , with a rate of decays of approximately 1 Bq per kg [9].

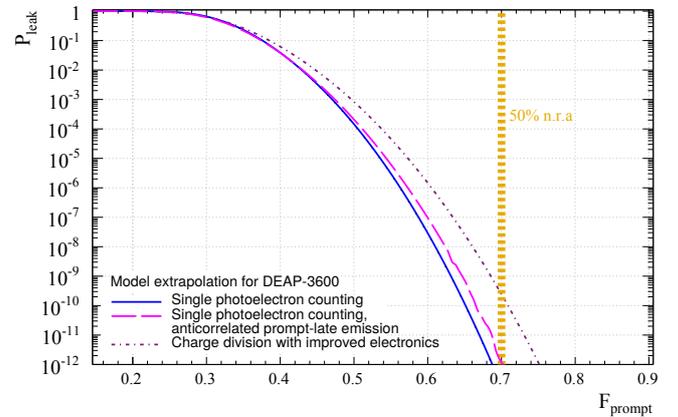


Figure 35: Leakage estimation at 120 to 240 PE for a detector with 255 PMTs and 8 PE/keV_{ee} light yield (15–30 keV_{ee} energy window). The underlying energy spectrum is that of the ^{39}Ar beta decay, PE counting is assumed to be accurate, and the energy dependence of the mean of the F_{prompt} distribution is taken from [38]. The solid line shows the analytic model without SPE or electronics noise, and the dotted line has the same SPE noise as the DEAP-1 measurement, but electronics noise per PMT is reduced to account for better read-out electronics and then scaled up to 255 PMTs. The dashed line was generated with a toy simulation following the logic of the analytic model and also assuming anticorrelation from binomial partition between prompt and late scintillation photons at a fixed energy. The window noise is taken from the DEAP-1 measurement. Nuclear recoil acceptance median is taken from the SCENE measurement [14] and corrected for differences in integration window definitions.

Since the model developed does not describe the data perfectly, and several of the input parameters will be different in the large detector, we calculate model predictions for the large detector using conservative estimates. The P_{leak} distribution given by Eq. (20) is shown in Fig. 35 with the binomial probability centred at $\bar{p} = 8/40$, corresponding to 8 PE/keV_{ee} light yield, for the energy region of 15–30 keV_{ee}. We use the ^{39}Ar energy spectrum in the energy convolution, and assume correct PE counting, i.e. the prompt and late-PE offsets are zero. To conservatively include a possible upturn in the true mean of the F_{prompt} distribution at lower energies, we implemented the energy dependence of mean F_{prompt} as observed in [38]. The leakage is calculated for the following cases: (a) assuming that SPE identification and counting analysis will make the electronics and SPE noise negligible, (b) using a simple DEAP-1 style charge division method for SPE calibration, i.e. the same SPE noise, with the electronics noise values from the DEAP-1 V1720 underground dataset scaled up to 255 PMTs (summed in quadrature), and late noise reduced by a factor of 6 to account for low-noise electronics and, additionally, (c) as an extreme case meaningful for a high light yield detector, a toy simulation discussed earlier in Sec. 5.1.4 was extended to include Fano fluctuation.

tuations in the total number of scintillation photons as well as a binomial fluctuation between the initial number of prompt and late scintillation photons, effectively adding maximal anticorrelation between both populations at a fixed energy (see Appendix A.4 for details). The window noise σ_w was in each case taken from the DEAP-1 model.

In order to suppress the ^{39}Ar background in the large detector to the required level of less than 0.2 events in a three-year run, PSD at the level of 10^{-10} is required. The model estimation in Fig. 35, using conservative model parameters, indicates that PSD at this level is possible in the energy region of 15–30 keV_{ee} at 50% nuclear recoil acceptance if the electronic and SPE noise can be kept sufficiently low. The uncertainty on this extrapolation is necessarily large, and is again dominated by the accuracy with which photoelectrons are counted.

In the large detector, each of the 255 PMTs will detect on average less than a single PE per region-of-interest event, so that PMT hits are going to be well separated. Single PE identification and counting will then bring substantial improvement over the simple charge integration and division method used in DEAP-1 analysis, so that the electronic and SPE noise parameters will likely be negligible compared to the statistical and detector noise in Eqs. (18) and (19).

The leakage in DEAP-1 diverges from the model curve due to pileup events. These are much easier to identify in the large detector, again because each PMT here will have on average less than 1 PE per region-of-interest event, so a sensitive statistical likelihood test can be constructed by considering the number of PE per PMT and using the expected time structure of LAr scintillation.

Recent work has shown that there is a possibility of obtaining argon that has been sequestered underground and is depleted in ^{39}Ar by more than a factor of 1000 [40, 41].

Figure 36 shows the 90% C.L. sensitivity versus WIMP mass for both natural and depleted argon cases, compared to the current experimental limits of the CDMS-II [42], DarkSide-50 [43], PICO-60 [44], PandaX-I [45], XENON100 [46] and LUX [47] experiments. We used standard assumptions for the galactic halo outlined in reference [48] and assumed a nuclear recoil scintillation efficiency of 25% compared to electrons [13].

7. Summary

We have shown that pulse-shape discrimination in liquid argon can be used to separate electron and nuclear recoil events, respectively induced by γ 's and by neutrons, in the energy region 44–89 keV_{ee} known with 6% systematic uncertainty, with a leakage of less than

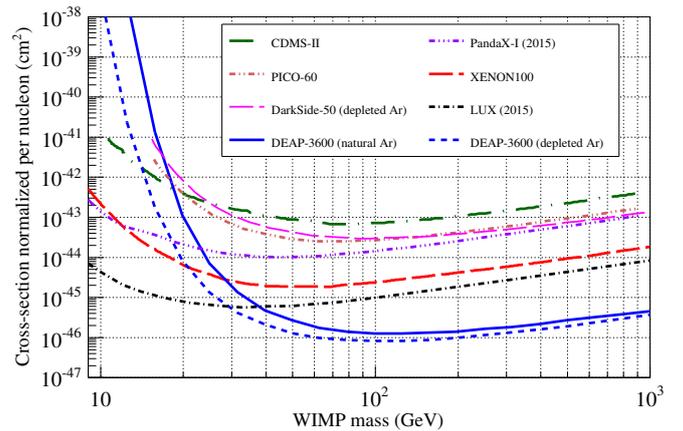


Figure 36: Dark matter sensitivity of liquid argon. Shown are the current experimental limits from the CDMS-II, DarkSide-50, PICO-60, PandaX-I, XENON100 and LUX collaborations, and the expected sensitivity for 3 tonne-years of liquid argon with a 15 keV_{ee} threshold, and with a 12 keV_{ee} threshold for argon that has been depleted in ^{39}Ar by a factor of 100. The DEAP-3600 curves do not take into account the sensitivity reduction due to the nuclear recoil acceptance less than 100%.

2.7×10^{-8} (90% C.L.) for 90% nuclear recoil detection efficiency.

This is the highest discrimination factor reported for liquid argon and improves by an order of magnitude the result reported by microCLEAN [19] (for 60–128 keV of nuclear recoil energy and for a nuclear recoil acceptance of 50%) and by a factor of ~ 5 the result reported by DarkSide-50 [4] (1.5×10^7 events collected in 8.6–65.6 keV_{ee} energy range with no leakage for nuclear recoil acceptance of 90%).

An analytic model, which assumes beta-binomial distributions for the singlet and triplet components of the scintillation signal and accounts for statistical and systematic sources of noise in these distributions, describes the main features of the observed F_{prompt} distribution above 21 keV_{ee} and above 0.28 F_{prompt} . This model, using conservative estimates for parameters not well known at lower energies, projects a discrimination power in argon of approximately 10^{-10} at 15 keV_{ee} and 50% nuclear recoil acceptance, for a detector with 8 photoelectrons per keV_{ee} light yield, which allows for sufficient background rejection of ^{39}Ar in a 1000-kg liquid argon dark matter search experiment.

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Appendix A. Deriving the F_{prompt} distribution - general framework

The time arrival profile of photo-electrons (PE) is detected for each event. The numbers of PE arriving in a given prompt time window, n_p , and those arriving in a given late time window, n_l , are counted. The total number of PE in the event, TotalPE, is $n_p + n_l = n_t$. Over the course of an experiment a wide range of events of varying TotalPE are recorded, with associated distributions of prompt and late PE. We denote these as $T(n_t)$, $P(n_p)$ and $L(n_l)$ and label them as “free parent distributions” for reasons that will become clear in following sections. The functional form of the free parent distributions are the empirical result of a combination of the microscopic physics and the particularities of the experimental detection, such as detector geometry and electronics. Their means are labeled μ_t , μ_p and μ_l .

Pulse shape discrimination between electron-recoil and nuclear-recoil events is achieved using the F_{prompt} parameter $f \equiv n_p/(n_p + n_l)$ and we are interested in the functional form, $R(f, N_{pe})$, that describes the distribution of f at any particular fixed number TotalPE = N_{pe} . Of particular interest are the “tails” of the $R(f, N_{pe})$ distribution, that is to say the behaviour of the function far away from its peak, since it is the tails which determine the experiment’s ability to discriminate between an enormous quantity of electron-recoil events and the rare nuclear-recoil events.

The functional form of the F_{prompt} distribution is first derived for events from interactions with fixed energy that are detected with a specific number of TotalPE. This basic functional form is then extended to distributions for the case where interactions with many energies contribute, or where events with a range of TotalPE are included, obtained through summation.

Some general properties and assumptions are:

Ionizing particles of energy E will create events with a TotalPE distribution whose mean is related to the interaction energy through the detector light yield, $\mu_t = E \cdot Y$, and the following derivations assume that the

light yield is approximately constant in the energy range of interest. The mean of the TotalPE distribution from many events, μ_t , is representative of the energy of the particles measured in PE, while n_t is the detected number of PE of an individual event, and the n_t are distributed about the mean μ_t due to particularities of the apparatus and detection medium that result in a finite energy resolution.

Additionally, the means of the Prompt and Late distributions are always related through the mean of the F_{prompt} distribution at a given energy, $\bar{f}_p(E)$,

$$\mu_p(E) = \bar{f}_p(E) \mu_t(E) \quad (\text{A.1})$$

$$\mu_l(E) = (1 - \bar{f}_p(E)) \mu_t(E) \quad (\text{A.2})$$

Furthermore, at a given energy the probability distribution for TotalPE can be written as the convolution between the Prompt and Late distributions:

$$\begin{aligned} T_E(n_t) &= (P_E(n_p) * L_E(n_l))(n_t) \\ &= \sum_{n_p=0}^{\infty} P_E(n_p) \cdot L_E(n_t - n_p) \end{aligned} \quad (\text{A.3})$$

where the subscript E makes explicit that interactions at a particular energy are considered.

Appendix A.1. Mono-energetic events at fixed TotalPE

Consider a radioactive calibration source that can produce events of a known fixed energy E .

At a fixed TotalPE, $n_t = N_{pe}$ where N_{pe} is a constant. The probability for a mono-energetic event to be observed with n_p prompt PE is denoted $P'_E(n_p; N_{pe})$, and likewise for n_l , $L'_E(n_l; N_{pe})$. $P'_E(n_p; N_{pe})$ can be computed by taking the original probability to observe any event with n_p prompt PE and multiplying this by the probability to find the matching number of $n_l = N_{pe} - n_p$ late PE.

$$P'_E(n_p; N_{pe}) = P_E(n_p) \cdot L_E(N_{pe} - n_p) \quad (\text{A.4})$$

$$L'_E(n_l; N_{pe}) = L_E(n_l) \cdot P_E(N_{pe} - n_l) \quad (\text{A.5})$$

We call Eq. (A.4) and (A.5) the primed or constrained distributions. Note that these distributions are perfectly anti-correlated. The sum of the primed distribution over all possible values of n_t is the free distribution.

$$\sum_{n_t=0}^{N_{pe}} P'_E(n_p; N_{pe}) = P_E(n_p) \quad (\text{A.6})$$

$$\sum_{n_t=0}^{N_{pe}} L'_E(n_p; N_{pe}) = L_E(n_p) \quad (\text{A.7})$$

The relationship between the free and primed Prompt and Late distributions is illustrated in Fig. A.37 for the

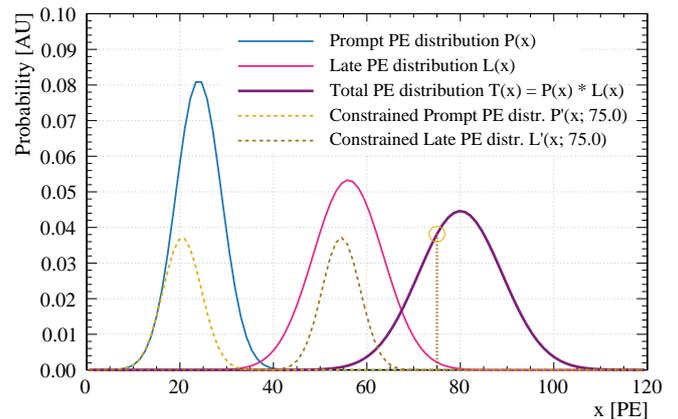


Figure A.37: The relationships between the free and constrained distributions, Eqs. (A.4, A.5), shown for the case of Gaussian distributions. The TotalPE distribution (bold purple) is a Gaussian with mean $\mu_t = 80$ PE, $\bar{f}_p = 0.3$, and has associated Gaussian free parent Prompt (blue) and Late (pink) distributions with means $\mu_p = 24$ PE and $\mu_l = 56$ PE. Only a subset of events within the free parent Prompt and Late distributions contribute to those events of TotalPE=75. These subsets are the constrained distributions shown in orange and brown. The constrained distributions in this specific example happen to be also Gaussians.

case of Gaussian parent distributions (see details in Appendix B).

By definition, each event from the population with constant $n_t = N_{pe}$ has a discrimination parameter $f = n_p/N_{pe}$; that is the F_{prompt} distribution for fixed TotalPE is entirely determined by the Prompt distribution. Hence the F_{prompt} distribution for events of common energy E that are detected with fixed TotalPE N_{pe} is equal to the distribution P' after a simple variable transformation¹⁴.

$$R_E(f; N_{pe}) = N_{pe} \cdot P'_E(n_p = f \cdot N_{pe}; N_{pe}) \quad (\text{A.8})$$

Eqs. (A.8) and (A.4) are the basic building blocks of **any** F_{prompt} distribution as will be discussed in the following sections.

Appendix A.2. Mono-energetic events at any TotalPE

One can obtain the F_{prompt} distribution for all events of the same energy E , regardless of each event's particular n_t , by summing the F_{prompt} distributions at fixed TotalPE = N_{pe} over all values of N_{pe} :

$$R_E(f) = \sum_{N_{pe}=0}^{\infty} N_{pe} \cdot P'_E(f N_{pe}; N_{pe}) \quad (\text{A.9})$$

This distribution fully describes the F_{prompt} distribution of data from a mono-energetic calibration source and without TotalPE binning, as long as there are negligible background contributions.

¹⁴If $n = f \cdot N_{pe}$, then $P(f)df = P'(n)dn$; hence $P(f) = P'(n)dn/df = P'(n)N_{pe}$.

Appendix A.3. Fixed TotalPE and multiple energies

More generally, the apparatus detects events from a variety of sources emitting an energy spectrum $N(E)$, so that events with a range of energies contribute to the F_{prompt} distribution for any given TotalPE. We build the primed Prompt distribution for this case by taking the primed Prompt distributions for each energy in the spectrum (Eq. (A.4)) and adding them up, each weighted by the probability $T_E(N_{pe})$ that an event of energy E is detected at N_{pe} :

$$P'(n_p; N_{pe}) = \int_0^\infty P'_E(n_p; N_{pe}) T_E(N_{pe}) N(E) dE \quad (\text{A.10})$$

And in F_{prompt} it is

$$\begin{aligned} R(f; N_{pe}) &= N_{pe} \cdot P'(n_p; N_{pe}) \\ &= N_{pe} \cdot P'(f \cdot N_{pe}; N_{pe}) \end{aligned} \quad (\text{A.11})$$

For practical calculation, the integral over E in Eq. (A.10) can be turned into a sum over μ_t .

Appendix A.4. Choice of parent distribution

Choosing the correct functional form for the free parent distributions is crucial to obtaining an accurate description of the tails, and in principle should be largely motivated by an understanding of the microscopic physics. In a realistic detector, this means that the number of PE detected should be drawn from a compound distribution characterizing each step of the photon emission and detection chain, for example in the form of convolutions between binomial, poisson, and Gaussian distributions as appropriate for each step.

Furthermore, a realistic detector has noise, non-uniformities, and ageing effects that cause the parent distribution's parameters to differ slightly between events. This is the case for example when photons emitted from different locations can have very different photon paths in the detector, or when the overall light yield changes with time. These effects modify the parameters that determine the photon survival probability at each step, namely the rate parameter in a poisson distribution or the success probability in a binomial distribution. Noise, such as electronics noise, modifies the final PE count after the number of PE are drawn from the parent distribution and thus can be modelled by convoluting the parent distribution with the noise distribution over the distribution argument (the PE-count). Effects that modify the photon survival probability also modify the final PE count, but they do so by changing the parent distribution parameters that the number of PE are drawn from, so that over all events, the parent distribution parameters are now themselves distributed as some probability distribution. This situation must be modelled by convoluting the parent distribution with the distribution of its parameter over the parent distribution mean. The

technical difference between convoluting over the distribution mean or the distribution argument has a small effect near its peak, but a significant effect in the tails.

To include detector effects that modify the 'success probability' or photon survival probability p , we distribute p as a beta distribution around a mean of \bar{p} . We choose a beta distribution for this because of its flexible shape and because the result is an analytic function: the beta-binomial distribution

$$\text{Binomial}(n; \mu, \text{Beta}(\bar{p}, b)) = \text{BetaBin}(n; \mu, \bar{p}, b) \quad (\text{A.12})$$

where the Beta distribution is explicitly parametrized in terms of its mean \bar{p} and shape parameter b , which are related to the often used α and β parameters as $\bar{p} = \alpha/(\alpha + \beta)$ and $b = \alpha$. An analytic description minimizes computation time and reduces the complexity of the equations in the final F_{prompt} model. The shape parameter b of the beta distribution can be seen as a dispersion parameter that quantifies the beta-binomial's amount of dispersion over the ideal binomial case.

Since we desire a description of the F_{prompt} distribution for all μ_p/l of interest, care must be taken to parametrize the distribution in such a way that the relative dispersion remains constant at different μ . The nominal beta-binomial distribution is

$$\begin{aligned} \text{BetaBin}(n; \mu, \bar{p}, \alpha) &\equiv \frac{\Gamma(\frac{\mu}{\bar{p}} + 1)}{\Gamma(n + 1)\Gamma(\frac{\mu}{\bar{p}} - n + 1)} \\ &\times \frac{\Gamma(n + \alpha)\Gamma(\frac{\mu}{\bar{p}} - n + \alpha(\frac{1}{\bar{p}} - 1))\Gamma(\frac{\alpha}{\bar{p}})}{\Gamma(\frac{\mu}{\bar{p}} + \frac{\alpha}{\bar{p}})\Gamma(\alpha)\Gamma(\alpha(\frac{1}{\bar{p}} - 1))} \end{aligned} \quad (\text{A.13})$$

and to obtain a proper behaviour of the dispersion with μ , the parameter α is parametrized as $\alpha = b\mu$. For $p \ll b$, the variance of Eq. (A.13) is then

$$\sigma_{\text{BetaBin}}^2 = \mu(1 + 1/b) \quad (\text{A.14})$$

The difference in shape between the beta-binomial (binomial convolved with beta distribution with respect to the binomial probability), binomial convolved with a Gaussian (over the distribution argument), and pure Gaussian distributions is illustrated in Fig. A.38. Note in particular the different behaviour of the tails.

Since the overall photon survival probability is relatively small in DEAP-1 probabilistic effects associated with photon detection dominate over those coming from the emission process, so that taking a single binomial distribution to approximate both was justified in the main part of the paper. This assumption starts to fail in 120–240 PE range for light yields higher than in DEAP-1 and binomial fluctuation between the numbers of emitted prompt and late photons can no longer be neglected. Extending the analytic model to the most general case, i.e. to combine the (anticorrelated) binomial partition between prompt and late scintillation photons with the survival probabilities and noise terms

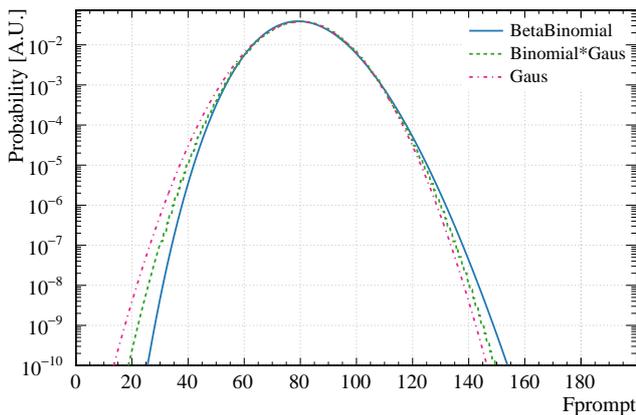


Figure A.38: Comparison of beta-binomial (blue solid), binomial*Gaussian (green dashed), and Gaussian (red dash-dot) distributions at $\mu = 80$ PE and binomial probability $\bar{p} = 0.06$. All distributions have a variance of $\sigma^2 = 112$ PE².

for both populations poses a number of computational challenges, while it can be added to a Monte Carlo model in a rather straightforward way. In this work we have chosen the approach of analytically approximating the parent distributions for a high light yield detector with the detection-related PDFs only and neglecting the emission effects. The additional contribution from emission processes is evaluated with a toy simulation (see Fig. 35). Work on further extensions of the analytical model is ongoing.

Appendix A.4.1. Adding uncorrelated noise

The beta-binomial distribution has an inherent width representing purely statistical fluctuation, or “statistical noise”. It also models what we describe as “detector noise” through a dispersion parameter, quantifying non-uniformity of the detector that leads to n_p and n_l being drawn from a range of underlying binomial distributions.

Additional uncorrelated noise has to be added to account for the variation in charge of an SPE pulse and for the signal processing noise from detection electronics. We call the standard deviation of these noise components $\sigma_{p,l}$, and model them as having Gaussian shape. The two free parent distributions then each consist of the near-ideal beta-binomial probability distribution, convolved with the noise Gaussian over n_p and n_l .

Appendix A.4.2. Adding window noise

Window noise, σ_w , is a detection effect related to the uncertainty in the location of the event peak, and thus in where to stop counting prompt and start counting late light. It is 100% anti-correlated noise that randomly

moves counts from the late into the prompt region¹⁵ without affecting the sum count.

If this source of noise were included with the Gaussian noise terms discussed in Appendix A.4.1, multiplying the uncorrelated distributions in Eq. (A.4) would require careful consideration of the correlation terms. Due to the perfect anti-correlation, it is straight-forward to instead consider this effect separately; it randomly adds or subtracts from the n_p in the constrained distribution $P'_E(n_p; N_{pe})$, which we model by convolving P' with a Gaussian of width σ_w ,

$$P'_{wn}(n_p; N_{pe}) = \sum_{n'_p=0}^{\infty} P'(n'_p; N_{pe}) \cdot \text{Gaus}(n'_p, n_p, \sigma_w) \quad (\text{A.15})$$

with

$$\text{Gaus}(x, \mu, \sigma) = \frac{1}{\sqrt{2\pi}\sigma} e^{-\frac{1}{2}\left(\frac{x-\mu}{\sigma}\right)^2} \quad (\text{A.16})$$

The distribution in the F_{prompt} variable is found as in Eq. (A.11).

Appendix B. The F_{prompt} distribution for Gaussian parent distributions

For large numbers of PE, the free Prompt and Late distributions can be well described by Gaussians. At smaller numbers of PE, and near the tails, the Gaussian approximation is progressively worse, and the measured distributions may only be approximated by Gaussians near their peaks. Even though this approach does not describe the F_{prompt} distribution adequately at the TotalPE region of interest in this paper, some general properties or the constrained distributions can be derived using the simple assumption of Gaussian parent distributions.

The Gaussians describing the Prompt and Late distributions are initially of ideal statistical width, given by the root of their mean. These are then convolved with the noise Gaussian

$$P_E(n_p) = \text{Gaus}(n_p; \mu_p(E), \sqrt{\mu_p}) * \text{Gaus}(0, \mu_p(E), \sigma_{p-}(n_t)) = \text{Gaus}(n_p; \mu_p(E), \sigma_p(n_p, E)) \quad (\text{B.1})$$

$$L_E(n_l) = \text{Gaus}(n_l; \mu_l(E), \sqrt{\mu_l}) * \text{Gaus}(0, \mu_l(E), \sigma_{l-}(n_t)) = \text{Gaus}(n_l; \mu_l(E), \sigma_l(n_t, E)) \quad (\text{B.2})$$

where we used the fact that the convolution of two Gaussians is itself a Gaussian [49], and $\sigma_{p,l-}$ denotes the distribution width without the statistical (\sqrt{N}) component.

¹⁵The probability for prompt counts to move into the late region is negligible due to the length of the prompt window and the short singlet decay time.

Using Eq. (A.3) written as a single Gaussian, we get for the distribution in TotalPE:

$$T_E(n_t) = \text{Gaus}(n_t, \mu_t, \sigma_t) \quad (\text{B.3})$$

where

$$\mu_t = \mu_p + \mu_l \quad (\text{B.4})$$

$$\sigma_t = \sqrt{\sigma_p^2 + \sigma_l^2} \quad (\text{B.5})$$

Eq. (A.4) is used to obtain the distribution of n_p that contribute to N_{pe} TotalPE:

$$P'_E(n_p) = \frac{1}{2\pi\sigma_p\sigma_l} e^{-\frac{1}{2}\left(\frac{n-\mu_p}{\sigma_p}\right)^2} e^{-\frac{1}{2}\left(\frac{N_{pe}-n-\mu_l}{\sigma_l}\right)^2} \quad (\text{B.6})$$

$$= \frac{1}{2\pi\sigma_p\sigma_l} e^{-\frac{1}{2}\left(\frac{n-\mu_p}{\sigma_p}\right)^2} e^{-\frac{1}{2}\left(\frac{n-(N_{pe}-\mu_l)}{\sigma_l}\right)^2} \quad (\text{B.7})$$

$$= \text{Gaus}(n_p, \mu'_p, \sigma_{pl}) \quad (\text{B.8})$$

with [49]

$$\sigma_{pl} = \sqrt{\frac{\sigma_p^2 \cdot \sigma_l^2}{\sigma_p^2 + \sigma_l^2}} \quad (\text{B.9})$$

$$\mu'_p = \frac{\mu_p\sigma_l^2 + (N_{pe} - \mu_l)\sigma_p^2}{\sigma_p^2 + \sigma_l^2} \quad (\text{B.10})$$

Note that the equation for $L'_E(n_l)$ follows a parallel argument so that

$$L'_E(n_l) = \text{Gaus}(n_l, \mu'_l, \sigma_{pl}) \quad (\text{B.11})$$

with

$$\mu'_l = \frac{\mu_l\sigma_p^2 + (N_{pe} - \mu_p)\sigma_l^2}{\sigma_p^2 + \sigma_l^2} \quad (\text{B.12})$$

In the case of purely statistical noise, i.e. $\sigma_p = \sqrt{\mu_p}$, $\sigma_l = \sqrt{\mu_l}$ this simplifies to

$$\sigma_{pl}^2 = \bar{f}_p \cdot \mu_t (1 - \bar{f}_p) \quad (\text{B.13})$$

$$\mu'_p = \bar{f}_p \cdot N_{pe} \quad (\text{B.14})$$

$$\mu'_l = (1 - \bar{f}_p) \cdot N_{pe} \quad (\text{B.15})$$

If the noise has terms not proportional to $\sqrt{\mu}$, μ'_p and μ'_l will be shifted by some amount. For example, if

$$\sigma_p^2 = a\mu + c_p \quad (\text{B.16})$$

$$\sigma_l^2 = a\mu + c_l \quad (\text{B.17})$$

then correlated means become:

$$\mu'_p = \frac{\mu_p(c_l + aN_{pe}) + c_p(N_{pe} - \mu_l)}{a\mu_t + c_p + c_l} \quad (\text{B.18})$$

$$\mu'_l = \frac{\mu_l(c_p + aN_{pe}) + c_l(N_{pe} - \mu_p)}{a\mu_t + c_p + c_l} \quad (\text{B.19})$$

The shift is such that the mean F_{prompt} is unaffected.

Eq. (A.9) evaluates to the uncorrelated Hinkley function [50], also called the Gaussian ratio distribution (after a variable transformation from $w = n_p/n_l$ to $f = n_p/(n_p + n_l)$ where then $w = f/(1 - f)$).

Eq. (A.10) becomes:

$$P'(n_p; N_{pe}) = \int_0^\infty \text{Gaus}(n_p; \mu'_p(E), \sigma_{pl}(n_p, E)) \times \text{Gaus}(N_{pe}, \mu_t(E), \sigma_t(E)) \cdot N(E) dE \quad (\text{B.20})$$

Written in F_{prompt} and setting $E \cdot Y = \mu_t$:

$$R(f; N_{pe}) = N_{pe} \cdot P'(N_{pe}f; N_{pe}) = \int_0^\infty \frac{N_{pe}}{2\pi \sigma_t(E) \sigma_{pl}(E)} e^{-\frac{1}{2}\left(\frac{f - \mu'_p(E)/N_{pe}}{\sigma_{pl}(E)/N_{pe}}\right)^2} \times e^{-\frac{1}{2}\left(\frac{N_{pe} - \mu_t(E)}{\sigma_t(E)}\right)^2} N(\mu_t) d\mu_t \quad (\text{B.21})$$

and

$$\sigma_t \sigma_{pl(E)} = \sigma_{p(E)} \sigma_{l(E)} \quad (\text{B.22})$$

where we explicitly indicated all parameters that are a

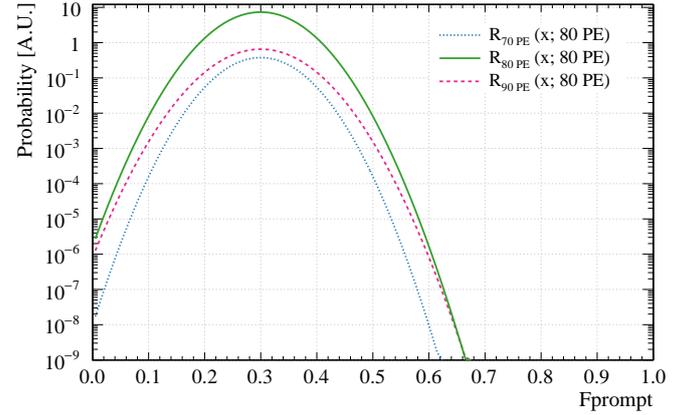


Figure B.39: The contributions to the F_{prompt} distribution at a detected 80 PE, for a source that emits events of only three different energies (corresponding to TotalPE distribution means of 70, 80, and 90 PE) each with the same probability. The observed F_{prompt} distribution would be the sum of the three curves.

function of energy.

At any given TotalPE, the F_{prompt} distribution is composed of the sum of the F_{prompt} distributions from events of many different energies, with each distribution weighted by its probability of occurring.

The width of each of these component distributions, $\sigma_{pl}(E)$ is monotonously increasing with energy, thus $\sigma_{pl}(E_1) < \sigma_{pl}(E_2)$ if $E_1 < E_2$, which means that events from higher energies contribute more weight to the sum F_{prompt} distributions than events from lower energies. In particular, this means that the tails of the sum distribution are more strongly influenced by events from higher energies.

This is illustrated in Fig. B.39, where Eq. (B.21) is drawn for $N_{pe} = 80$ PE, and events from three different energies whose TotalPE distribution means, μ_t , are 70, 80, and 90 PE. Each energy is taken as equally likely and the energy resolution is $\sigma_{pl} = \sqrt{1.12\mu}$. Due to its larger standard deviation, the curve for events from the higher energy is both more dominant and relatively wider than the curve from the smaller energy events. Above 0.6 f, the contribution from higher energy events and the otherwise dominant energy for the given TotalPE bin are about equal.

Appendix C. Mis-calibration of the energy scale

The statistical description of the F_{prompt} distribution requires the precise knowledge of the number of PE in an event, at least on average. It is sensitive to systematic mis-calibration of the energy scale where the measured values of the Prompt and Late means, $\hat{\mu}_p$ and $\hat{\mu}_l$, are wrong by δ_p and δ_l and a common constant a ,

$$\hat{\mu}_p = a\mu_p + \delta_p \quad (\text{C.1})$$

$$\hat{\mu}_l = a\mu_l + \delta_l \quad (\text{C.2})$$

$$\hat{\mu}_t = \hat{\mu}_p + \hat{\mu}_l \quad (\text{C.3})$$

$$= a\mu_t + \delta_t \quad (\text{C.4})$$

where μ_p and μ_l are the true values.

The true mean F_{prompt} value \bar{f}_p is

$$\bar{f}_p = \frac{\mu_p}{\mu_p + \mu_l} = \frac{\mu_p}{\mu_t} \quad (\text{C.5})$$

and assumed constant for all energies, though the extension to energy dependent \bar{f}_p is straight forward.

We derive the functional form of the observed mean F_{prompt} \hat{f}_p , the observed prompt and late distribution means, and the observed standard deviation, $\hat{\sigma}_{pl}$, as a function of observed TotalPE $\hat{\mu}_t$.

The observed distribution means can be expressed as

$$\hat{\mu}_p = a \cdot \bar{f}_p \mu_t + \delta_p \quad (\text{C.6})$$

$$= a \cdot \bar{f}_p \frac{1}{a} (\hat{\mu}_t - \delta_t) + \delta_p \quad (\text{C.7})$$

$$= \bar{f}_p (\hat{\mu}_t - \delta_t) + \delta_p \quad (\text{C.8})$$

$$\hat{\mu}_l = (1 - \bar{f}_p) (N_{pe} - \delta_p - \delta_l) + \delta_l \quad (\text{C.9})$$

The measured mean F_{prompt} becomes

$$\hat{f}_p = \frac{\hat{\mu}_p}{\hat{\mu}_p + \hat{\mu}_l} \quad (\text{C.10})$$

$$= \frac{a\mu_p + \delta_p}{a\mu_p + \delta_p + a\mu_l + \delta_l} \quad (\text{C.11})$$

$$= \frac{a\mu_p + \delta_p}{a\mu_t + \delta_t} \quad (\text{C.12})$$

dividing by $a\mu_t$

$$\hat{f}_p = \frac{f_p + \delta_p/(a\mu_t)}{1 + \delta_t/(a\mu_t)} \quad (\text{C.13})$$

and re-writing in terms of the measured TotalPE

$$\hat{f}_p = \frac{f_p + \delta_p/(\hat{\mu}_t - \delta_t)}{1 + \delta_t/(\hat{\mu}_t - \delta_t)} \quad (\text{C.14})$$

Eq. (C.14) shows that the mean F_{prompt} obtains a TotalPE-dependence even in the case where the true underlying mean F_{prompt} is constant with energy.

In the Gaussian approximation and with $\sigma_p \simeq \sqrt{\mu_p}$ (i.e. no constant terms), the variance of the correlated Prompt distribution is Eq. (B.9) to which we add the window noise:

$$\sigma_{pl;w}^2 = (1 - f_p)\mu_t f_p + (\epsilon_{\text{win}}(1 - f_p)\mu_t)^2 \quad (\text{C.15})$$

Re-writing in terms of the observed number of PE, and realizing that the calibration scaling applies to the width as well, so the measured width is $\sigma_{pl;w} = a\sigma_{pl;w}$:

$$\hat{\sigma}_{pl;w}^2 = a^2 \left[(1 - f_p) \frac{1}{a} (\hat{\mu}_t - \delta_t) f_p + \left(\epsilon_{\text{win}} (1 - f_p) \frac{1}{a} (\hat{\mu}_t - \delta_t) \right)^2 \right] \quad (\text{C.16})$$

$$= (1 - f_p) a (\hat{\mu}_t - \delta_t) f_p + (\epsilon_{\text{win}} (1 - f_p) (\hat{\mu}_t - \delta_t))^2 \quad (\text{C.17})$$